

Sub-part
2.1033(c):

EQUIPMENT IDENTIFICATION

FCC ID: LJPNSW-6NX

NAMEPLATE DRAWING

ATTACHED, EXHIBIT 1.

LOCATION

AS PER LABEL DRAWING(S)

DATE OF REPORT

April 1, 1999

SUPERVISED BY:


Morton Flom, P. Eng.

THE APPLICANT HAS BEEN CAUTIONED AS TO THE FOLLOWING:

15.21 INFORMATION TO USER.

The users manual or instruction manual for an intentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

15.27(a) SPECIAL ACCESSORIES.

Equipment marketed to a consumer must be capable of complying with the necessary regulations in the configuration in which the equipment is marketed. Where special accessories, such as shielded cables and/or special connectors are required to enable an unintentional or intentional radiator to comply with the emission limits in this part, the equipment must be marketed with, i.e. shipped and sold with, those special accessories. However, in lieu of shipping or packaging the special accessories with the unintentional or intentional radiator, the responsible party may employ other methods of ensuring that the special accessories are provided to the consumer, without additional charge.

Information detailing any alternative method used to supply the special accessories for a grant of equipment authorization or retained in the verification records, as appropriate. The party responsible for the equipment, as detailed in § 2.909 of this chapter, shall ensure that these special accessories are provided with the equipment. The instruction manual for such devices shall include appropriate instructions on the first page of text concerned with the installation of the device that these special accessories must be used with the device. It is the responsibility of the user to use the needed special accessories supplied with the equipment.

TABLE OF CONTENTS

RULE	DESCRIPTION	PAGE
	Test Report	1
2.1033(c)	General Information Required	2
2.1033(c)(14)	Rule Summary	4
	General Information	5
	Standard Test Conditions and Engineering Practices	6
2.1046(a)	R. F. Power Output (Radiated)	7
2.1047(a)	Audio Frequency Response	9
2.1047(a)	Audio Low Pass Filter (Voice Input)	11
2.1047(b), 22.915	Modulation Limiting	14
	Measurement of Maximum Deviation	17
2.1049(c)(1)	Part 22 Emission Masks (Occupied Bandwidth)	20
2.1049, 24.238(b)	Part 24 Emission Masks (Occupied Bandwidth)	38
22.917	Emission Limitations for Cellular	48
2.1051	Spurious Emissions at Antenna Terminals	59
2.1053(a)	Field Strength of Spurious Radiation	61
2.1055(a)(1)	Frequency Stability (Temperature Variation)	67
2.1055(b)(1)	Frequency Stability (Voltage Variation)	71
2.202(g)	Necessary Bandwidth and Emission Bandwidth	72

PAGE NO.

1 of 72.

Required information per ISO/IEC Guide 25-1990, paragraph 13.2:

a)

TEST REPORT

b) Laboratory: M. Flom Associates, Inc.
(FCC: 31040/SIT) 3356 N. San Marcos Place, Suite 107
(Canada: IC 2044) Chandler, AZ 85224

c) Report Number: d9940002

d) Client: Nokia Mobile Phones
Elektroniikkatie 10
Fin-90570
Oulu, Finland

e) Identification: 8860, Type NSW-6NX
FCC ID: LJPNSW-6NX
Description: Dual Mode, Tri-band Cellular Telephone

f) EUT Condition: Not required unless specified in individual tests.

g) Report Date: April 1, 1999
EUT Received: March 22, 1999

h, j, k): As indicated in individual tests.

i) Sampling method: No sampling procedure used.

l) Uncertainty: In accordance with MFA internal quality manual.

m) Supervised by:



Morton Flom, P. Eng.

n) Results: The results presented in this report relate only to the item tested.

o) Reproduction: This report must not be reproduced, except in full, without written permission from this laboratory.

PAGE NO. 2 of 72.

LIST OF GENERAL INFORMATION REQUIRED FOR CERTIFICATION

IN ACCORDANCE WITH FCC RULES AND REGULATIONS,
VOLUME II, PART 2 AND TO

22, 24

Sub-part 2.1033

(c)(1): NAME AND ADDRESS OF APPLICANT:

Nokia Mobile Phones
Elektroniikkatie 10
Fin-90570
Oulu, Finland

MANUFACTURER:

Nokia Manufacturing Inc U.S.A.
4201 Diplomacy Road
Centreport 2
Fort Worth, TX 76155

(c)(2): FCC ID: LJPNSW-6NX

MODEL NO: 8860, Type NSW-6NX

(c)(3): INSTRUCTION MANUAL(S):

PLEASE SEE ATTACHED EXHIBITS

(c)(4): TYPE OF EMISSION:

AMPS-FM:	40K0F8W
	40K0F1D
AMPS-TDMA:	30K0DXW
PCS-TDMA:	30K0DXW

(c)(5): FREQUENCY RANGE, MHz:

AMPS-FM:	824.04 to 848.97
AMPS-TDMA:	824.04 to 848.97
PCS-TDMA:	1850.04 to 1909.92

(c)(6): POWER RATING, Watts:

AMPS-FM:	0.66 W ERP
AMPS-TDMA:	0.50 W ERP
PCS-TDMA:	0.63 W EIRP

___ Switchable ___ x Variable ___ N/A

(c)(7): MAXIMUM POWER RATING, Watts: 0.6

PAGE NO. 3 of 72.

Subpart 2.1033 (continued)

(c)(8): VOLTAGES & CURRENTS IN ALL ELEMENTS IN FINAL R. F. STAGE, INCLUDING FINAL TRANSISTOR OR SOLID STATE DEVICE:

COLLECTOR CURRENT, A = per manual
COLLECTOR VOLTAGE, Vdc = per manual
SUPPLY VOLTAGE, Vdc = 3.6

(c)(9): TUNE-UP PROCEDURE:

PLEASE SEE ATTACHED EXHIBITS

(c)(10): CIRCUIT DIAGRAM/CIRCUIT DESCRIPTION:

Including description of circuitry & devices provided for determining and stabilizing frequency, for suppression of spurious radiation, for limiting modulation and limiting power.

PLEASE SEE ATTACHED EXHIBITS

(c)(11): LABEL INFORMATION:

PLEASE SEE ATTACHED EXHIBITS

(c)(12): PHOTOGRAPHS:

PLEASE SEE ATTACHED EXHIBITS

(c)(13): DIGITAL MODULATION DESCRIPTION:

 ATTACHED EXHIBITS
 X N/A

(c)(14): TEST AND MEASUREMENT DATA:

FOLLOWS

Accessories used during testing:

Travel Charger	ACP-7U
Performance Travel Charger	ACP-8U
Two Slot Desk Top Charger	CGE-1
Headset	HDC-5
Xena Battery Ni-MH 600mAh	BMP-1D

PAGE NO.

4 of 72.

Sub-part

2.1033(c)(14):

TEST AND MEASUREMENT DATA

All tests and measurement data shown were performed in accordance with FCC Rules and Regulations, Volume II; Part 2, Sub-part J, Sections 2.947, 2.1033(c), 2.1041, 2.1046, 2.1047, 2.1079, 2.1051, 2.1053, 2.1055, 2.1057 and the following individual Parts:

- ☐ 21 - Domestic Public Fixed Radio Services
- ☒ 22 - Public Mobile Services
- ☐ 22 Subpart H - Cellular Radiotelephone Service
- ☐ 22.901(d) - Alternative technologies and auxiliary services
- ☐ 23 - International Fixed Public Radiocommunication services
- ☒ 24 - Personal Communications Services
- ☐ 74 Subpart H - Low Power Auxiliary Stations
- ☐ 80 - Stations in the Maritime Services
- ☐ 80 Subpart E - General Technical Standards
- ☐ 80 Subpart F - Equipment Authorization for Compulsory Ships
- ☐ 80 Subpart K - Private Coast Stations and Marine Utility Stations
- ☐ 80 Subpart S - Compulsory Radiotelephone Installations for Small Passenger Boats
- ☐ 80 Subpart T - Radiotelephone Installation Required for Vessels on the Great Lakes
- ☐ 80 Subpart U - Radiotelephone Installations Required by the Bridge-to-Bridge Act
- ☐ 80 Subpart V - Emergency Position Indicating Radiobeacons (EPIRB'S)
- ☐ 80 Subpart W - Global Maritime Distress and Safety System (GMDSS)
- ☐ 80 Subpart X - Voluntary Radio Installations
- ☐ 87 - Aviation Services
- ☐ 90 - Private Land Mobile Radio Services
- ☐ 94 - Private Operational-Fixed Microwave Service
- ☐ 95 Subpart A - General Mobile Radio Service (GMRS)
- ☐ 95 Subpart C - Radio Control (R/C) Radio Service
- ☐ 95 Subpart D - Citizens Band (CB) Radio Service
- ☐ 95 Subpart E - Family Radio Service
- ☐ 95 Subpart F - Interactive Video and Data Service (IVDS)
- ☐ 101 - Fixed Microwave Services

GENERAL INFORMATION

1. Prior to testing, the deviation for audio modulation and each of the respective SAT + ST tones were set as close as possible to the required limit.
2. Except for audio modulation, which was applied externally, Wideband Data SAT, ST and all other tones and operational modes were provided by a test control unit incorporating appropriate software. Worst case repetition rate for Wideband Data was 10 kb/s.
3. Spurious radiation was measured at three (3) meters.
4. The two cellular frequency bands are available to the user automatically. Please refer to the manual contained in the documentation.
5. The normal modes of modulation are:
 - ☒ (a) VOICE
 - ☒ (b) WIDEBAND DATA
 - ☒ (c) SAT
 - ☒ (d) ST
 - ☒ (e) SAT + VOICE
 - ☒ (f) SAT + DTMF
 - ☐ (g) CDMA
 - ☒ (h) TDMA
 - ☐ (i) NAMPS VOICE
 - ☐ (j) NAMPS DSAT
 - ☐ (k) NAMPS ST
 - ☐ (l) NAMPS VOICE + DSAT

PAGE NO.

6 of 72.

STANDARD TEST CONDITIONS
and
ENGINEERING PRACTICES

Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-1992, section 6.1.9, and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst case measurements.

PAGE NO. 7 of 72.

NAME OF TEST: R. F. Power Output (Radiated)

SPECIFICATION: 47 CFR 2.1046(a)

GUIDE: ETIA/EIA/IS-137-A-1996

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE (RADIATED)

1. The EUT was placed on an open-field site and its radiated field strength at a known distance was measured by means of a spectrum analyzer. Equivalent loading was calculated from the equation $P_t = ((E \times R)^2 / 49.2)$ watts, where $R = 3m$.
2. Measurement accuracy is ± 1.5 dB.

MEASUREMENT RESULTS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV/m	CF, dB	uV/m @ 3m	ERP, dBm	ERP, Watts
-------------------------	----------------------------	------------------	--------	-----------	-------------	---------------

STATE: 1:Low Power AMPS MODE g9930182: 1999-Mar-22 Mon 10:50:00

824.040000	824.038000	73.01	30.66	152580.84	6.25	0.004
836.400000	836.398000	72.04	30.69	136930.44	5.35	0.003
848.970000	848.968000	71.43	30.73	128233.06	4.75	0.003

STATE: 1:Low Power AMPS-TDMA g9930184: 1999-Mar-22 Mon 13:20:00

824.040000	824.050000	61.80	30.66	41975.9	-4.95	0.0003
836.400000	836.410000	63.97	30.69	54075.43	-2.75	0.0005
848.970000	848.975000	64.24	30.73	56040.24	-2.45	0.0006

STATE: 2:High Power AMPS MODE g9930181: 1999-Mar-22 Mon 09:40:00

824.040000	824.038000	94.92	30.66	1901078.28	28.25	0.66
836.400000	836.398000	93.99	30.69	1713957.31	27.35	0.54
848.970000	848.968000	92.61	30.73	1468926.28	25.95	0.40

STATE: 2:High Power AMPS-TDMA g9930183: 1999-Mar-22 Mon 11:31:00

824.040000	824.028000	93.31	30.66	1579428.61	26.55	0.46
836.400000	836.403000	93.55	30.69	1629296.03	26.85	0.49
848.970000	848.983000	93.64	30.73	1653864.78	26.95	0.50

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV/m	CF, dB	uV/m @ 3m	EIRP, dBm	EIRP, Watts
-------------------------	----------------------------	------------------	--------	-----------	--------------	----------------

STATE: 1:Low Power PCS-TDMA g9930192: 1999-Mar-23 Tue 08:20:00

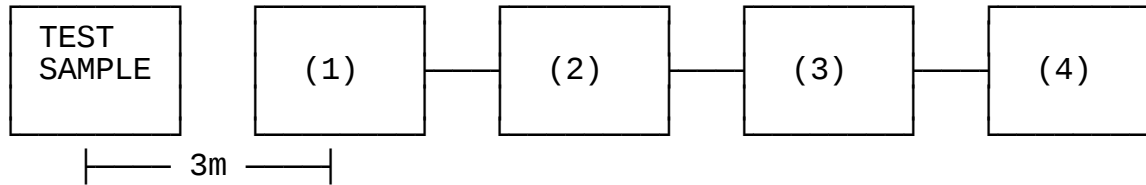
1850.040000	1850.055000	64.70	31.67	65841.54	-1.05	0.0002
1879.980000	1879.980000	59.67	31.24	35115.59	-6.45	0.0004
1909.920000	1909.925000	56.49	31.25	24378.11	-9.65	0.0002

STATE: 2:High Power PCS-TDMA g9930191: 1999-Mar-22 Mon 13:37:00

1850.040000	1850.038000	90.81	31.67	1330454.42	25.15	0.54
1879.980000	1879.980000	92.00	31.24	1452111.62	25.85	0.63
1909.920000	1909.935000	91.54	31.25	1378795.95	25.45	0.58

PAGE NO.

8 of 72.

TRANSMITTER RADIATED MEASUREMENTS

Asset	Description	s/n
(1) TRANSDUCER		
<u>x</u>	<u>i00091</u> Emco 3115	001469
<u>x</u>	<u>i00089</u> Aprel Log Periodic	001500
(2) HIGH PASS FILTER		
<u>x</u>	<u>i00</u> Narda μ PAD (In-Band Only)	
<u>x</u>	<u>i00</u> Trilithic	
	(Out-Of-Band Only)	
(3) PREAMP		
<u>x</u>	<u>i00028</u> HP 8449 (+30 dB)	2749A00121
(4) SPECTRUM ANALYZER		
<u>x</u>	<u>i00048</u> HP 8566B	2511A01467
	<u>i00043</u> HP 8558B	2004A02076
	<u>i00057</u> HP 8557A	1531A00191
<u>x</u>	<u>i00029</u> HP 8563E	3213A00104

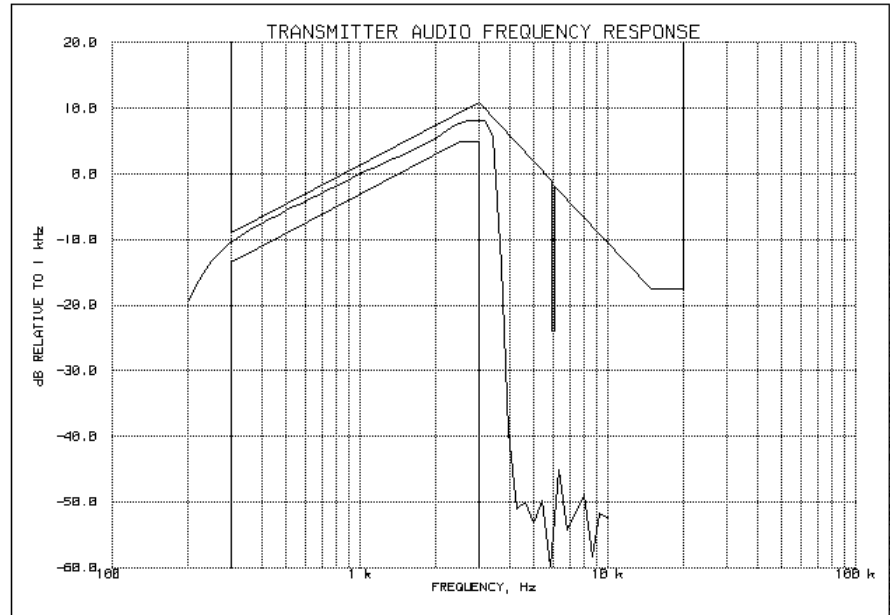
PAGE NO. 9 of 72.
NAME OF TEST: Audio Frequency Response
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: TIA/EIA/IS-137-A-1996
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page.
2. The audio signal generator was connected to the audio input circuit/microphone of the EUT.
3. The audio signal input was adjusted to obtain 20% modulation at 1 kHz, and this point was taken as the 0 dB reference level.
4. With input levels held constant and below limiting at all frequencies, the audio signal generator was varied from 100 Hz to 50 kHz.
5. The response in dB relative to 1 kHz was then measured, using the HP 8901A Modulation Analyzer.
6. MEASUREMENT RESULTS: ATTACHED

PAGE NO. 10 of 72.

NAME OF TEST: Audio Frequency Response
 g9930077: 1999-Mar-22 Mon 11:37:00
 STATE: 0:General



Additional points:

FREQUENCY, Hz	LEVEL, dB
300	-10.23
20000	-66.21
30000	-81.93
50000	-90.30

SUPERVISED BY:

M. Flom P. Eng.

Morton Flom, P. Eng.

PAGE NO. 11 of 72.
NAME OF TEST: Audio Low Pass Filter (Voice Input)
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: TIA/EIA/IS-137-A-1996
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

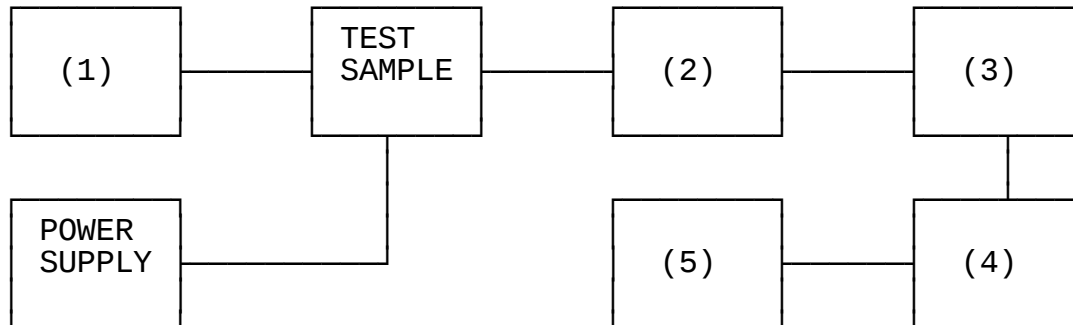
1. The EUT and test equipment were set up such that the audio input was connected at the input to the modulation limiter, and the modulated stage.
2. The audio output was connected at the output to the modulated stage.
3. MEASUREMENT RESULTS: ATTACHED

PAGE NO.

12 of 72.

TRANSMITTER TEST SET-UP

TEST A. MODULATION CAPABILITY/DISTORTION
 TEST B. AUDIO FREQUENCY RESPONSE
 TEST C. HUM AND NOISE LEVEL
 TEST D. RESPONSE OF LOW PASS FILTER
 TEST E. MODULATION LIMITING

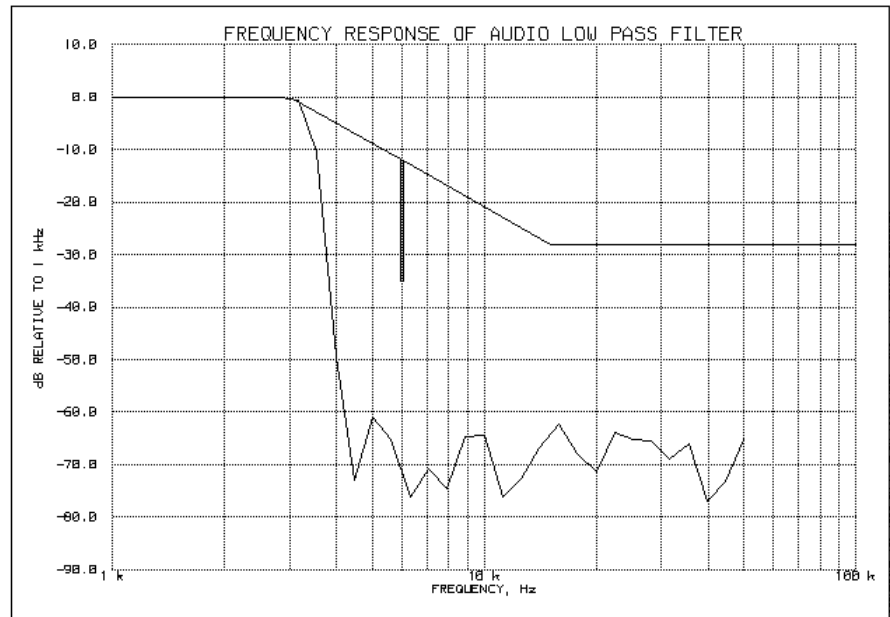


Asset	Description	s/n
<u>(1) LINE IMPEDANCE STABILIZATION NETWORK</u>		
	i00010 HP 204D	1105A04683
x	i00017 HP 8903A	2216A01753
x	i00118 HP 33120A	US36002064
<u>(2) COAXIAL ATTENUATOR</u>		
x	i00122 NARDA 766-10	7802
	i00123 NARDA 766-10	7802A
	i00113 SIERRA 661A-3D	1059
	i00069 BIRD 8329 (30 dB)	10066
<u>(3) MODULATION ANALYZER</u>		
x	i00020 HP 8901A	2105A01087
<u>(4) AUDIO ANALYZER</u>		
x	i00017 HP 8903A	2216A01753
<u>(5) SCOPE</u>		
	i00058 HP 1741A	2215A09356
	i00071 Tektronix 935	1935-B011343

PAGE NO.

13 of 72.

NAME OF TEST: Audio Low Pass Filter (Voice Input)
g9930079: 1999-Mar-22 Mon 11:42:00
STATE: 0:General



SUPERVISED BY:

M. Flom P. Eng.
Morton Flom, P. Eng.

PAGE NO. 14 of 72.

NAME OF TEST: Modulation Limiting

SPECIFICATION: 47 CFR 2.1047(b), 22.915

GUIDE: TIA/EIA/IS-137-A-1996

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The audio signal generator was connected to the audio input circuit/microphone of the EUT as for Frequency Response of the Audio Modulating Circuit.
2. The modulation response was measured for each of three tones (one of which was the frequency of maximum response), and the input voltage was varied and was observed on an HP 8901A Modulation Analyzer.
3. The audio input level was varied from 30% modulation (± 3.6 kHz deviation) to at least 20 dB higher than the saturation point.
4. Measurements were performed for both negative and positive modulation and the respective results were recorded.
5. MEASUREMENT RESULTS ATTACHED FOR:

COMPANDER ON:

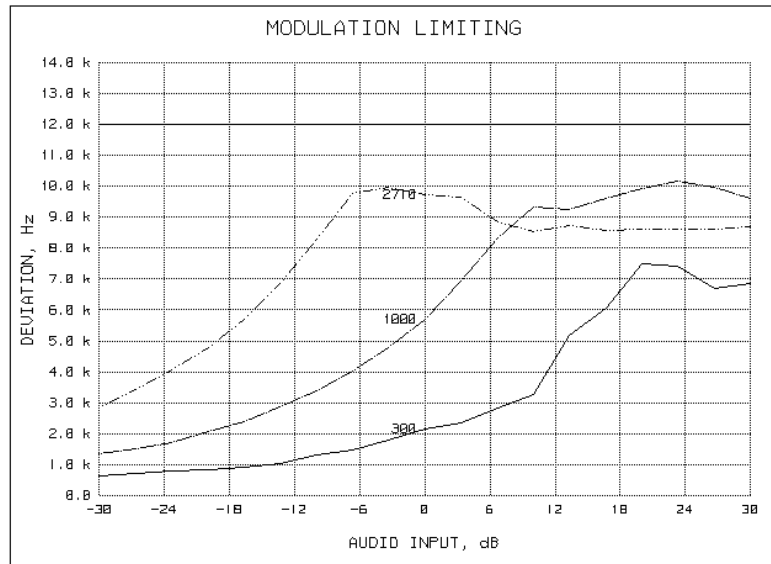
$\frac{x}{x}$ VOICE
 $\frac{x}{x}$ VOICE + SAT

PAGE NO.

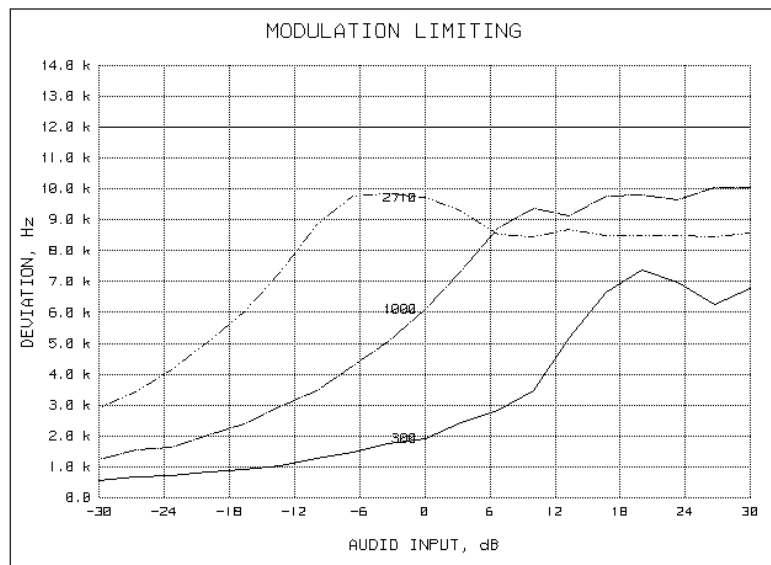
15 of 72.

NAME OF TEST: Modulation Limiting
 g9930151: 1999-Mar-25 Thu 09:06:00
 STATE: 0:General

Positive
 Peaks:



Negative
 Peaks:



SUPERVISED BY:

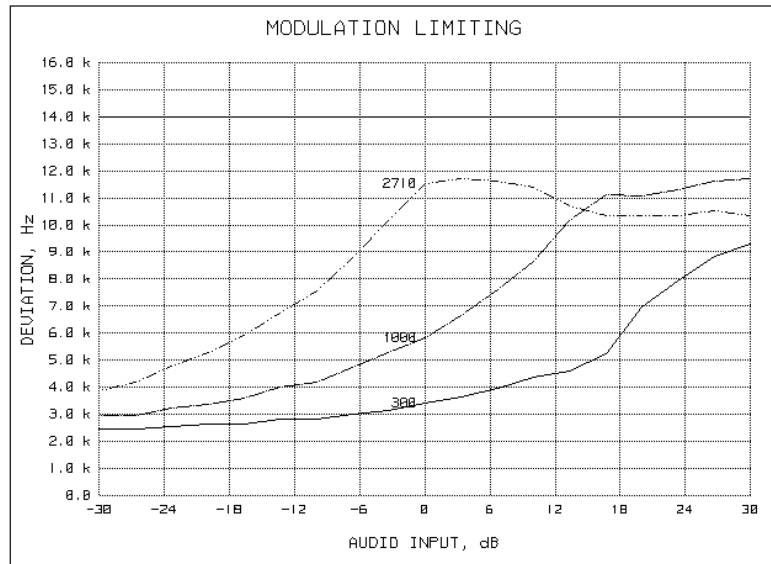
Morton Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO.

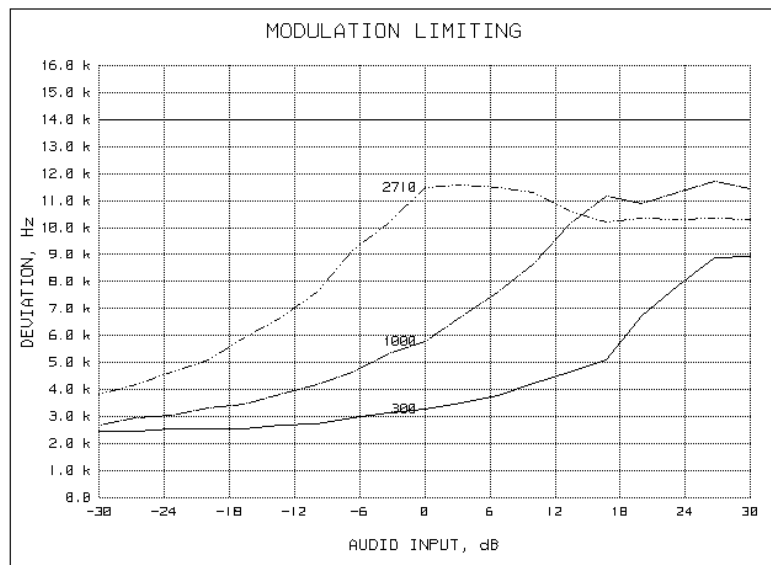
16 of 72.

NAME OF TEST: Modulation Limiting
 g9930152: 1999-Mar-25 Thu 09:12:00
 STATE: 0:General

Positive
 Peaks:



Negative
 Peaks:



SUPERVISED BY:

Morton Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 17 of 72.
NAME OF TEST: Measurement Of Maximum Deviation
GUIDE: TIA/EIA/IS-137-A-1996
TEST EQUIPMENT: As per attached page

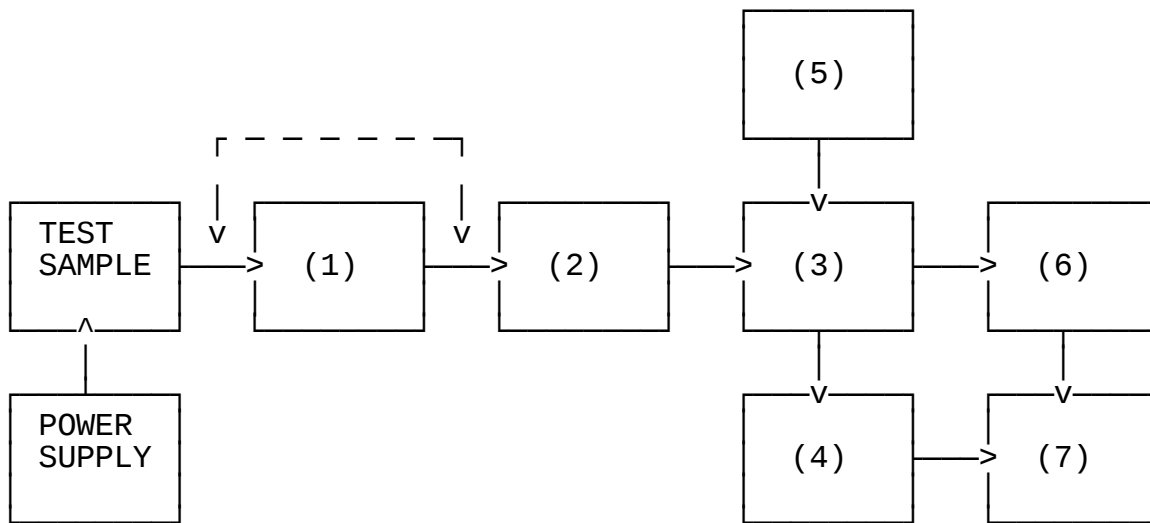
MEASUREMENT PROCEDURE

1. The presentation of tones was obtained by attaching the HP 8903A Oscilloscope to the Modulation Output of the HP 8901 Modulation Analyzer.
2. The EUT was modulated by an HP 8903 Audio Analyzer and/or internally generated signals.
3. Maximum deviation measurements were recorded for the various configurations.
4. MEASUREMENT RESULTS: ATTACHED SUMMARY FOR DEVIATION

PAGE NO.

18 of 72.

Measurement Of Maximum Deviation



Asset	Description	s/n
(1) <u>AUDIO OSCILLATOR/GENERATOR</u>		
<u>i00010</u>	HP 204D	1105A04683
x i00017	HP 8903A	2216A01753
(2) <u>COAXIAL ATTENUATOR</u>		
<u>i00122</u>	Narda 766-10	7802
x i00123	Narda 766-10	7802A
<u>i00113</u>	Sierra 661A-3D	1059
(3) <u>FILTERS; NOTCH, HP, LP, BP</u>		
<u>i00126</u>	Eagle TNF-1	100-250
<u>i00125</u>	Eagle TNF-1	50-60
x i00124	Eagle TNF-1	250-850
(4) <u>SPECTRUM ANALYZER</u>		
x i00048	HP 8566B	2511A01467
<u>i00029</u>	HP 8563E	3213A00104
(5) <u>SCOPE</u>		
x i00030	HP 54502A	2927A00209

PAGE NO.

19 of 72.

MEASUREMENT SUMMARY: Measurement Of Maximum Deviation

MODULATION	LIMIT, kHz	DEVIATION, MHz
(a) Voice	$\geq 10.8 \text{ \& } \leq 13.2$	10.8
(b) Wideband Data	$\geq 7.2 \text{ \& } \leq 8.8$	8.1
(c) SAT	$\geq 1.8 \text{ \& } \leq 2.2$	2.1
(d) ST	$\geq 7.2 \text{ \& } \leq 8.8$	7.8
(e) SAT + VOICE	N/A	11.6
(f) SAT + DTMF	N/A	11.0
(g) CDMA	N/A	N/A
(h) TDMA	N/A	N/A
(i) NAMPS VOICE	N/A	N/A
(j) NAMPS DSAT	N/A	N/A
(k) NAMPS ST	N/A	N/A
(l) NAMPS VOICE	N/A	N/A

SUPERVISED BY:



Morton Flom, P. Eng.

PAGE NO. 20 of 72.
NAME OF TEST: Emission Masks (Occupied Bandwidth)
SPECIFICATION: 47 CFR 2.1049(c)(1)
GUIDE: TIA/EIA/IS-137-A-1996
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page, with the Spectrum Analyzer connected.
2. For EUTs supporting audio modulation, the audio signal generator was adjusted to the frequency of maximum response and with output level set for ± 2.5 kHz deviation (or 50% modulation). With level constant, the signal level was increased 16 dB.
3. For EUTs supporting digital modulation, the digital modulation mode was operated to its maximum extent.
4. The Occupied Bandwidth was measured with the Spectrum Analyzer controls set as shown on the test results.
5. MEASUREMENT RESULTS: ATTACHED

PAGE NO. 21 of 72.

MEASUREMENT SUMMARY: Emission Masks (Occupied Bandwidth)

MODULATION	MEASURED DEVIATION ±kHz (HP 8901A)	LIMIT ±kHz	B/W @-26 dB PLOTS, kHz
NONE	0.0	0.0	0.0
VOICE	10.8	$\geq 10.8 \text{ \& } \leq 13.2$	24
WIDEBAND DATA	8.1	$\geq 7.2 \text{ \& } \leq 8.8$	25
SAT + VOICE	11.6	N/A	28
SAT + DTMF	11.0	N/A	26
CDMA	N/A	N/A	N/A
TDMA	N/A	N/A	28
NAMPS		N/A	N/A

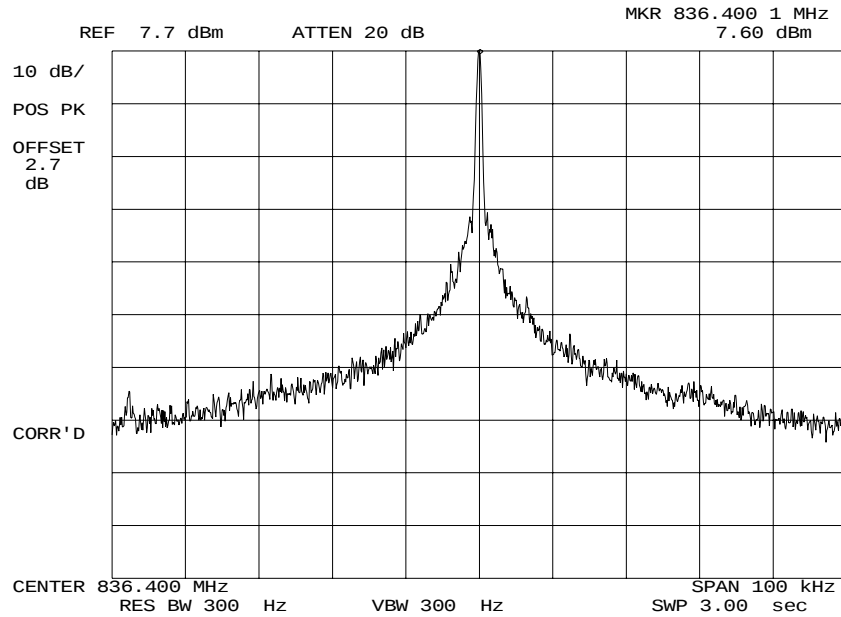
SUPERVISED BY:



Morton Flom, P. Eng.

PAGE NO. 22 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9930196: 1999-Mar-23 Tue 10:04:00
STATE: 1:Low Power



POWER:
MODULATION:

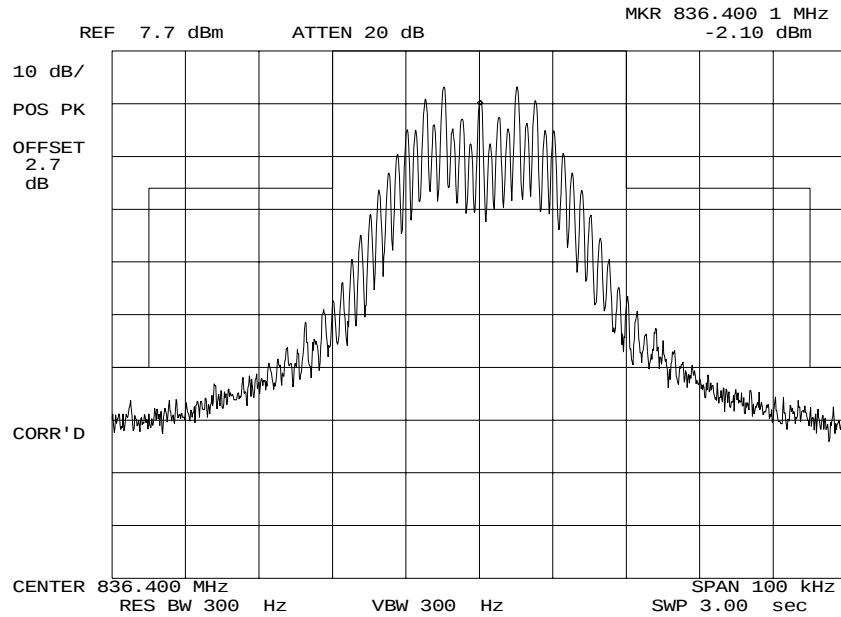
LOW
NONE

SUPERVISED BY:

M. Flom P. Eng.
Morton Flom, P. Eng.

PAGE NO. 23 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930199: 1999-Mar-23 Tue 10:16:00
 STATE: 1:Low Power



POWER:
 MODULATION:

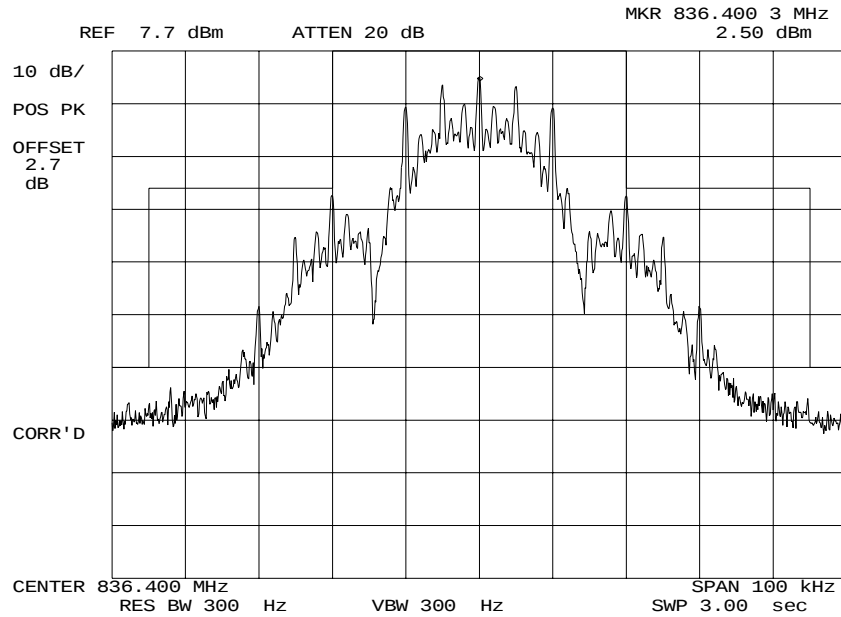
LOW
 VOICE: 2500 Hz SINE WAVE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 24 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930205: 1999-Mar-23 Tue 10:35:00
 STATE: 1:Low Power



POWER:
 MODULATION:

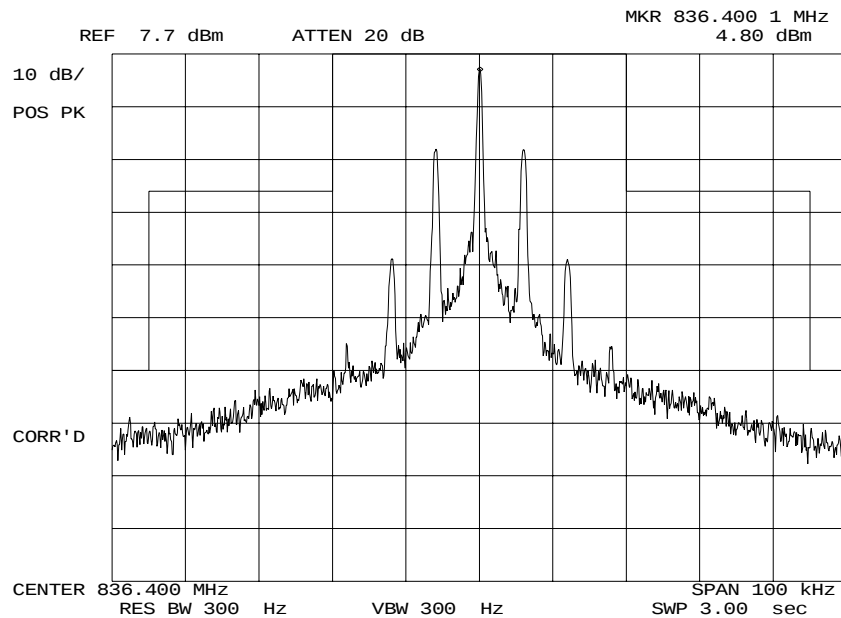
LOW
 WBD
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 25 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9930202: 1999-Mar-23 Tue 10:21:00
STATE: 1:Low Power



POWER:
MODULATION:

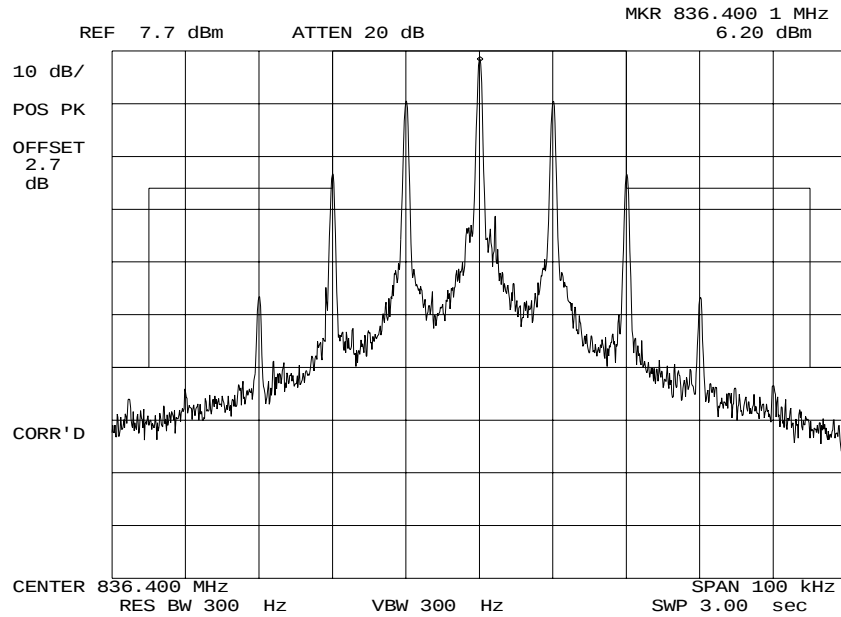
LOW
SAT
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
Morton Flom, P. Eng.

PAGE NO. 26 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930207: 1999-Mar-23 Tue 10:50:00
 STATE: 1:Low Power



POWER:
 MODULATION:

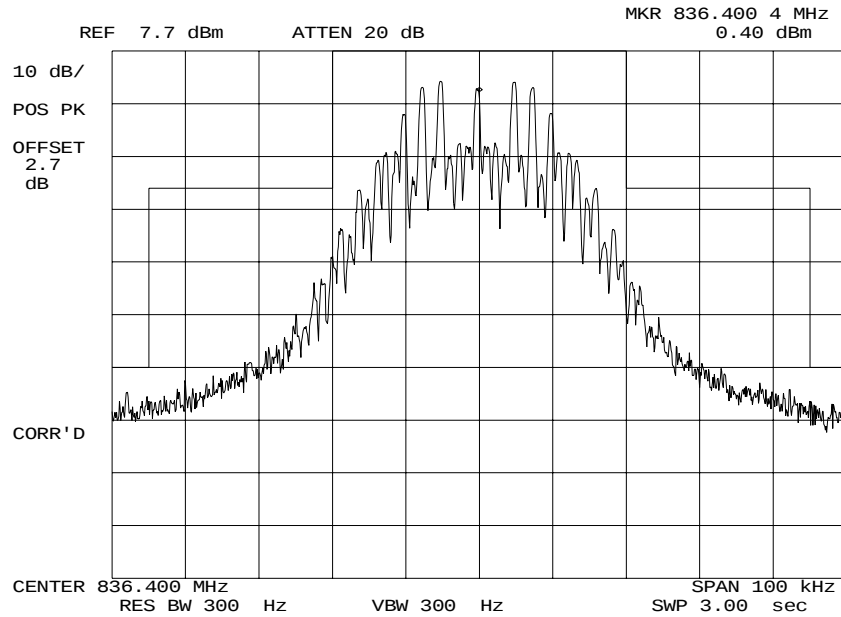
LOW
 ST
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 27 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930262: 1999-Mar-25 Thu 13:22:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 SAT+VOICE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

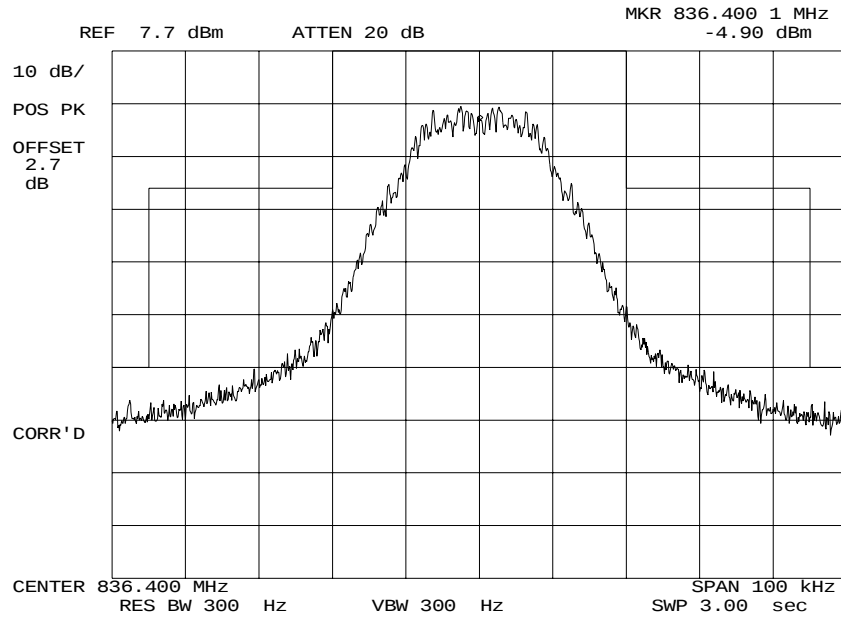
SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO.

28 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930209: 1999-Mar-23 Tue 10:55:00
 STATE: 1:Low Power



POWER:
 MODULATION:

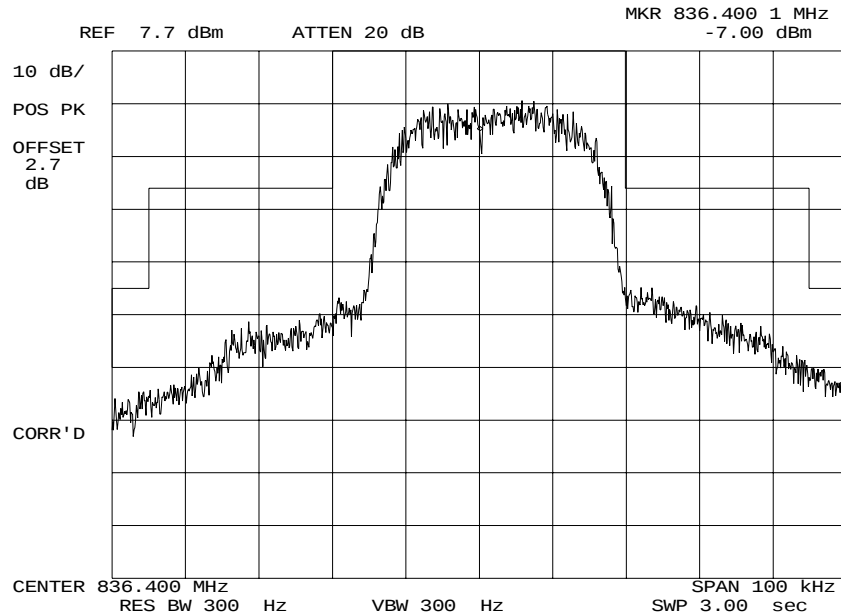
LOW
 SAT+DTMF
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO. 29 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930212: 1999-Mar-23 Tue 11:10:00
 STATE: 1:Low Power



POWER:
 MODULATION:

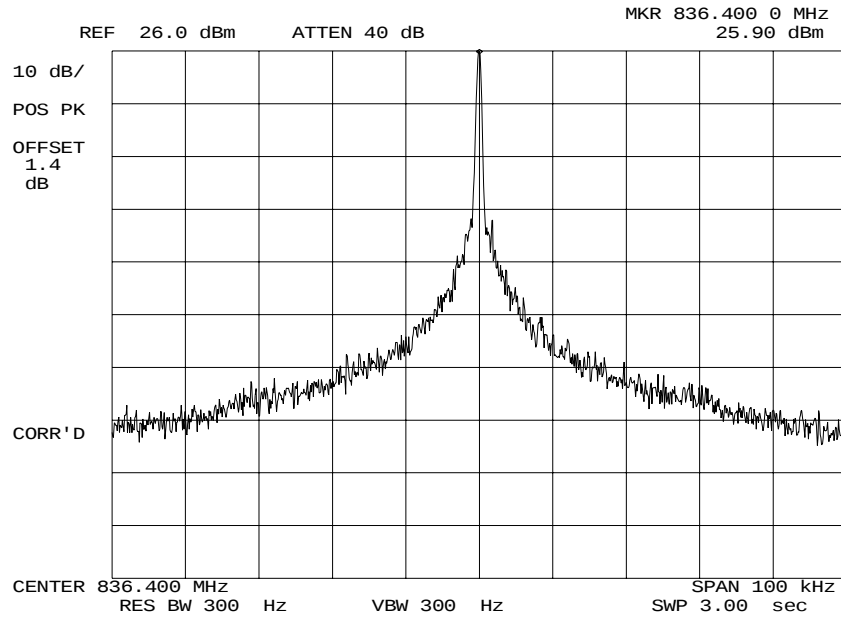
LOW
 TDMA
 MASK: AMPS CELLULAR, F1D,
 DATA

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 30 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930197: 1999-Mar-23 Tue 10:08:00
 STATE: 2:High Power



POWER:
 MODULATION:

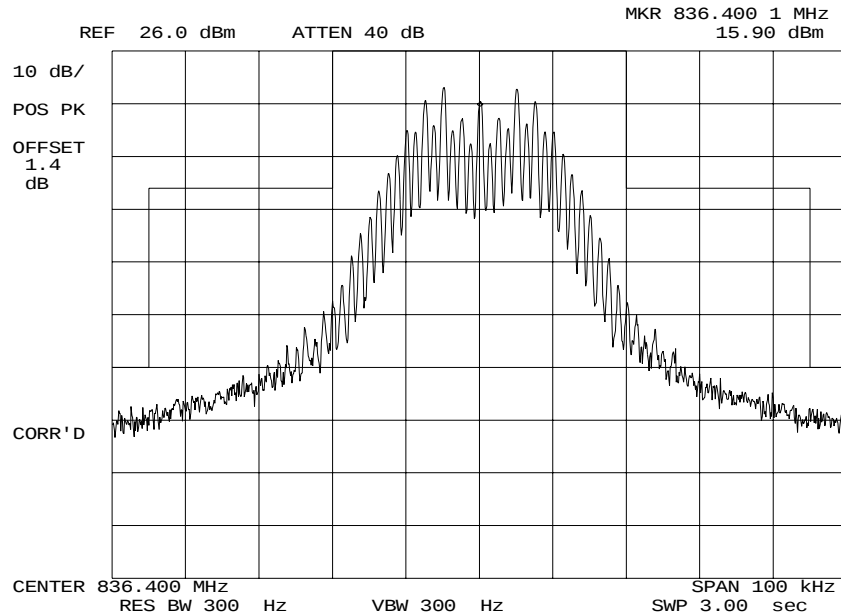
HIGH
 NONE

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 31 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930198: 1999-Mar-23 Tue 10:15:00
 STATE: 2:High Power



POWER:
 MODULATION:

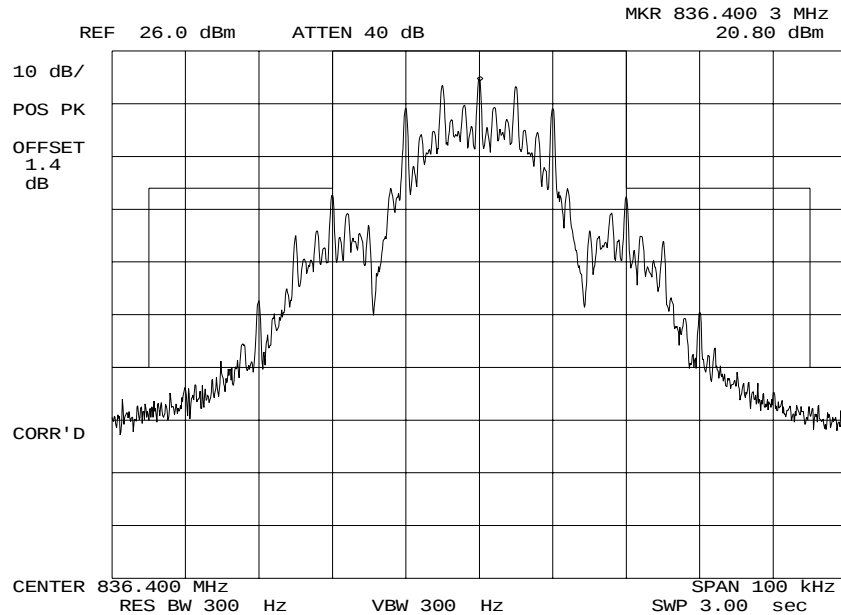
HIGH
 VOICE: 2500 Hz SINE WAVE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 32 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930204: 1999-Mar-23 Tue 10:34:00
 STATE: 2:High Power



POWER:
 MODULATION:

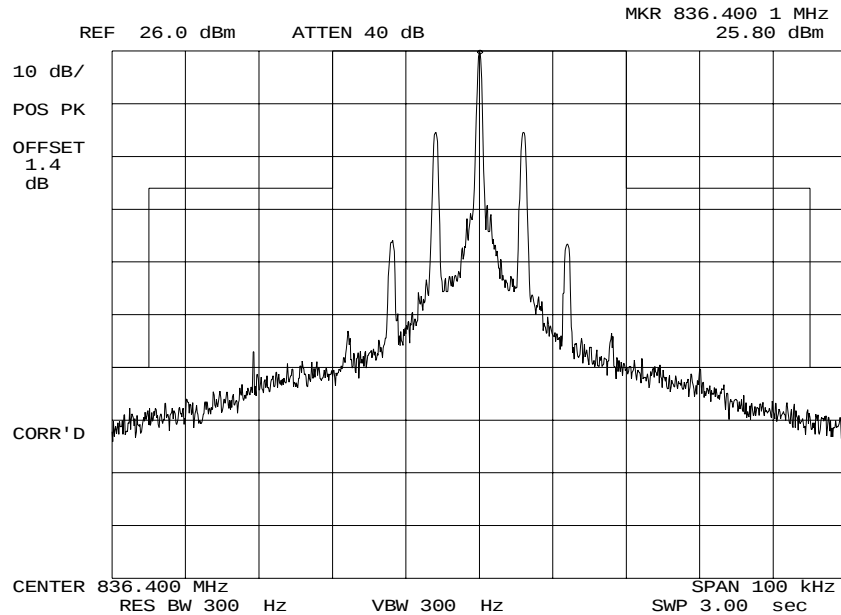
HIGH
 WBD
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 33 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9930203: 1999-Mar-23 Tue 10:23:00
STATE: 2:High Power



POWER:
MODULATION:

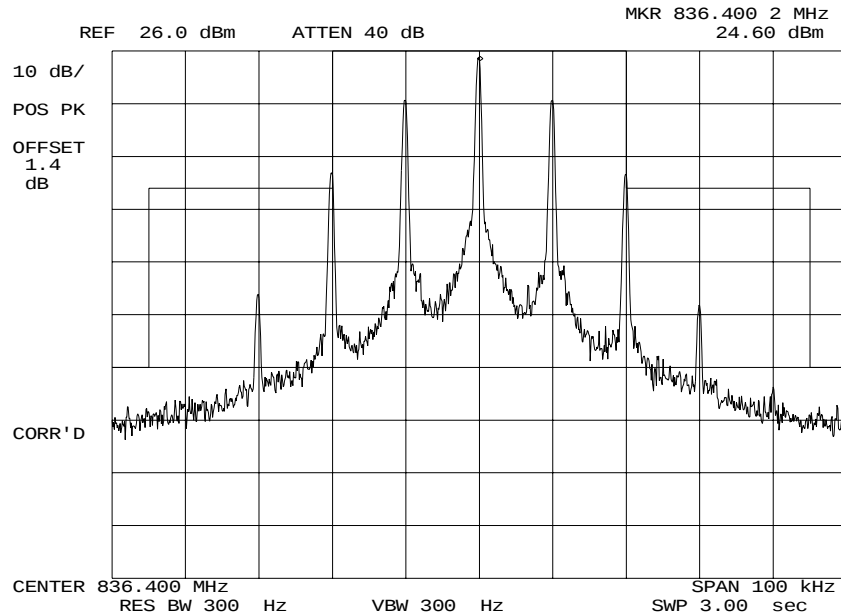
HIGH
SAT
MASK: AMPS CELLULAR,
F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
Morton Flom, P. Eng.

PAGE NO. 34 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930206: 1999-Mar-23 Tue 10:48:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 ST
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

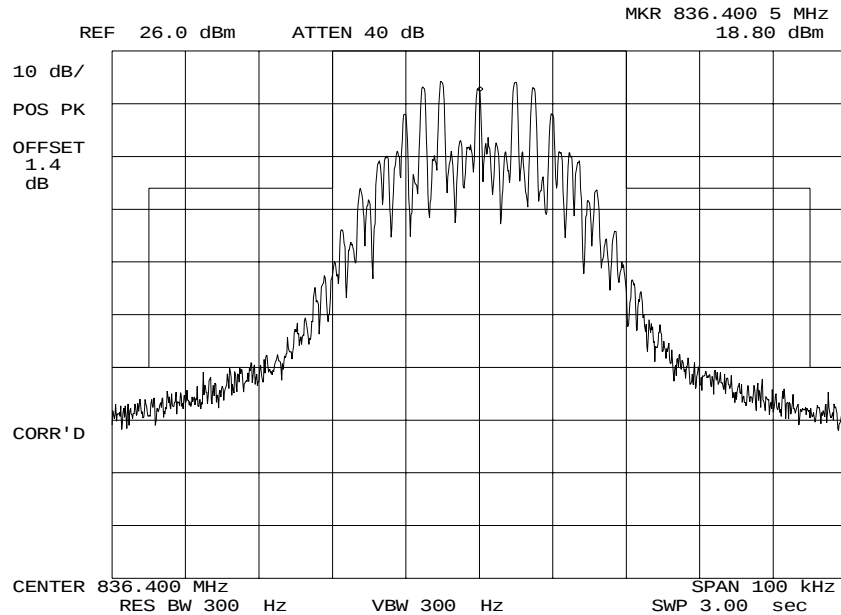
SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 34 of 72.

PAGE NO. 35 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930261: 1999-Mar-25 Thu 13:17:00
 STATE: 2:High Power



POWER:
 MODULATION:

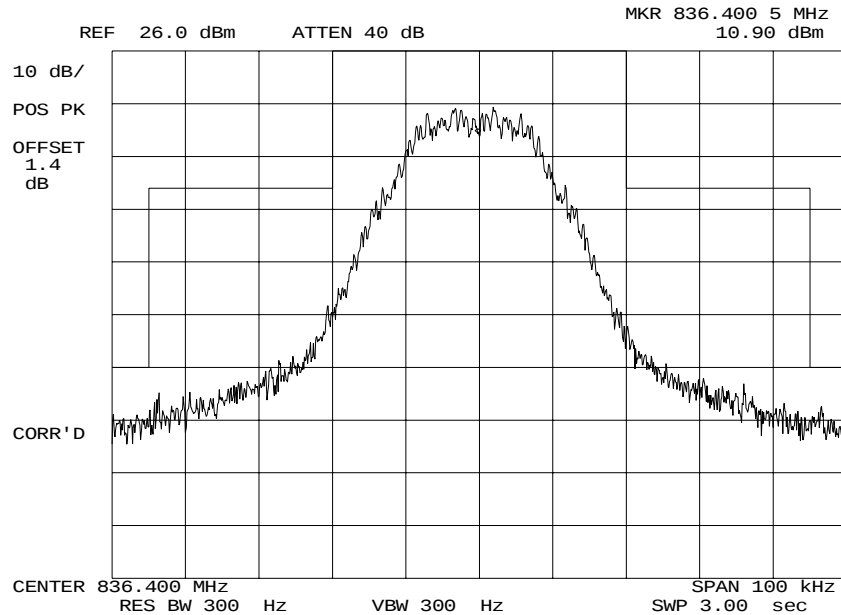
HIGH
 SAT+VOICE
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 36 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930208: 1999-Mar-23 Tue 10:52:00
 STATE: 2:High Power



POWER:
 MODULATION:

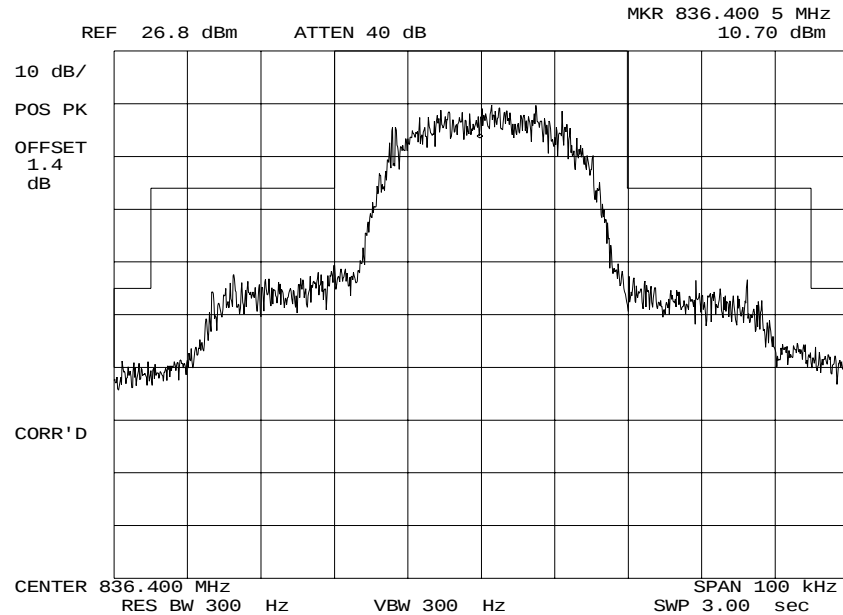
HIGH
 SAT+DTMF
 MASK: AMPS CELLULAR,
 F3E/F3D w/LPF

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 37 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930211: 1999-Mar-23 Tue 11:09:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 TDMA
 MASK: AMPS CELLULAR, F1D,
 DATA

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 38 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth

SPECIFICATION: 2.1049(c), 24.238(b): Occupied Bandwidth
24: Emissions at Band Edges

GUIDE: TIA/EIA/IS-137-A-1996

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page with the Spectrum Analyzer connected.
2. The low and high channels for all RF powers within the designated frequency block(s) were measured.
3. MEASUREMENT RESULTS: ATTACHED

SUPERVISED BY:

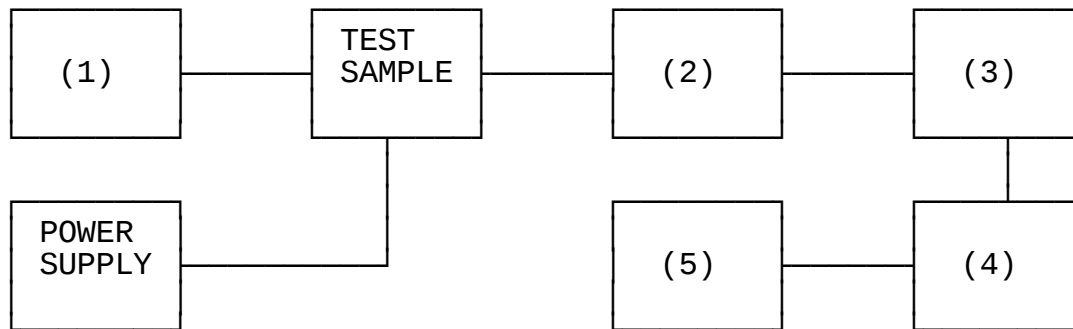

Morton Flom, P. Eng.

PAGE NO.

39 of 72.

TRANSMITTER SPURIOUS EMISSION

TEST A. OCCUPIED BANDWIDTH (IN-BAND SPURIOUS)
 TEST B. OUT-OF-BAND SPURIOUS

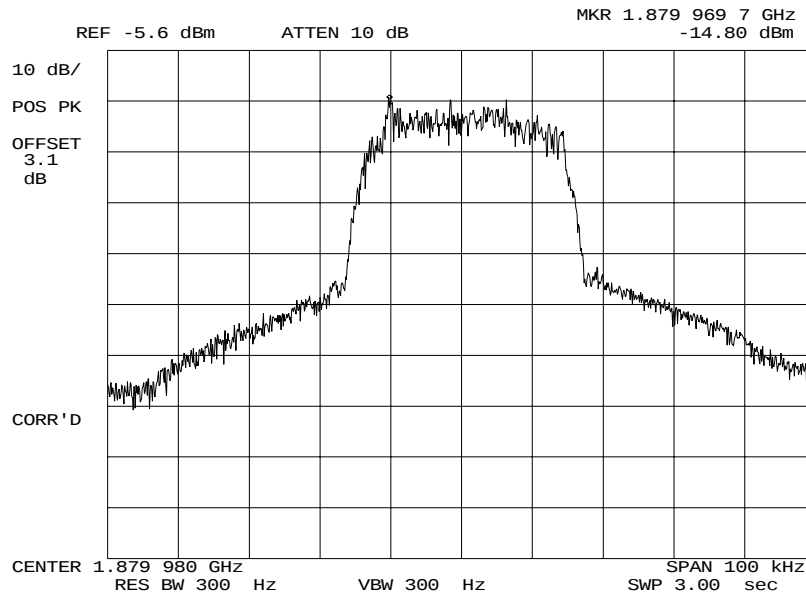


Asset	Description	s/n
(1)	AUDIO OSCILLATOR/GENERATOR	
_____	i00010 HP 204D	1105A04683
X _____	i00017 HP 8903A	2216A01753
_____	i00012 HP 3312A	1432A11250
(2)	COAXIAL ATTENUATOR	
X _____	i00122 Narda 766-10	7802
_____	i00123 Narda 766-10	7802A
_____	i00069 Bird 8329 (30 dB)	1006
_____	i00113 Sierra 661A-3D	1059
(3)	FILTERS; NOTCH, HP, LP, BP	
_____	i00126 Eagle TNF-1	100-250
_____	i00125 Eagle TNF-1	50-60
X _____	i00124 Eagle TNF-1	250-850
(4)	SPECTRUM ANALYZER	
X _____	i00048 HP 8566B	2511A01467
_____	i00029 HP 8563E	3213A00104
(5)	SCOPE	
_____	i00058 HP 1741A	2251A09356
_____	i00030 HP 54502A	2927A00209
_____	i00071 Tektronix 935	1935-B011343

PAGE NO.

40 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930236: 1999-Mar-23 Tue 14:31:00
 STATE: 1:Low Power



POWER:
 MODULATION:

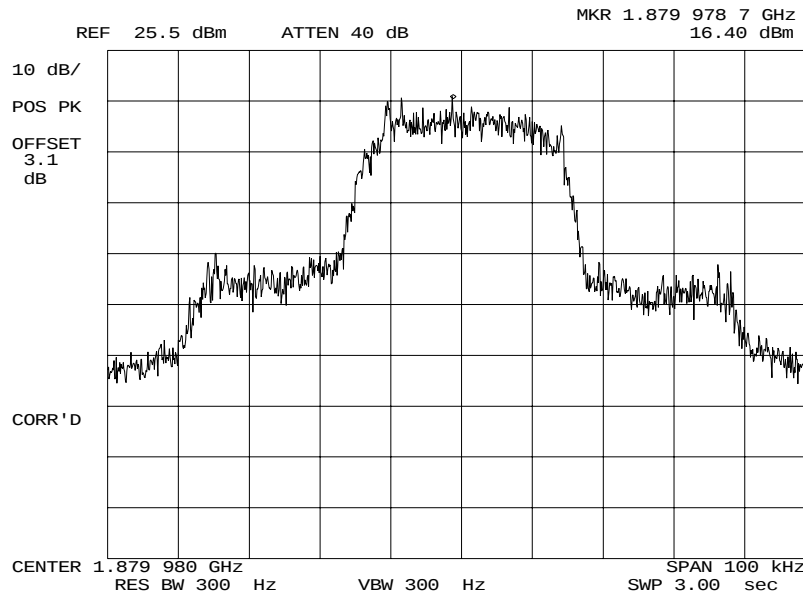
LOW
 TDMA

SUPERVISED BY:

Morton Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 41 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930235: 1999-Mar-23 Tue 14:27:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 TDMA

SUPERVISED BY:

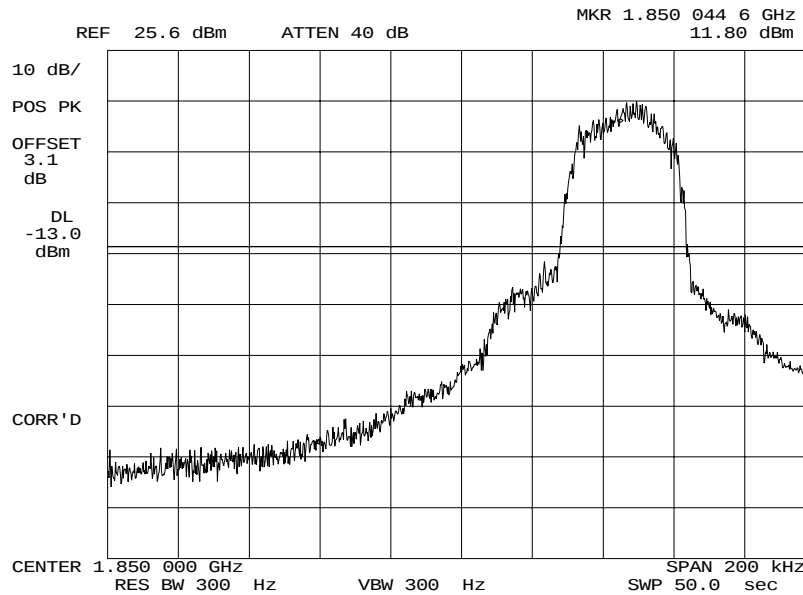
M. Flom P. Eng.

Morton Flom, P. Eng.

PAGE NO.

42 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9930271: 1999-Mar-29 Mon 11:34:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
TDMA PCS
LOWER BANDEDGE

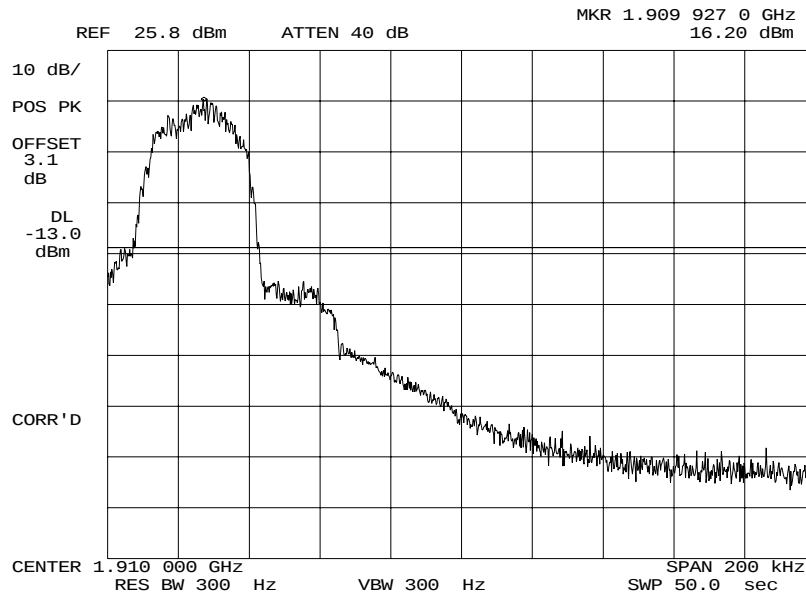
SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO.

43 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930272: 1999-Mar-29 Mon 11:40:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 TDMA PCS
 UPPER BANDEDGE

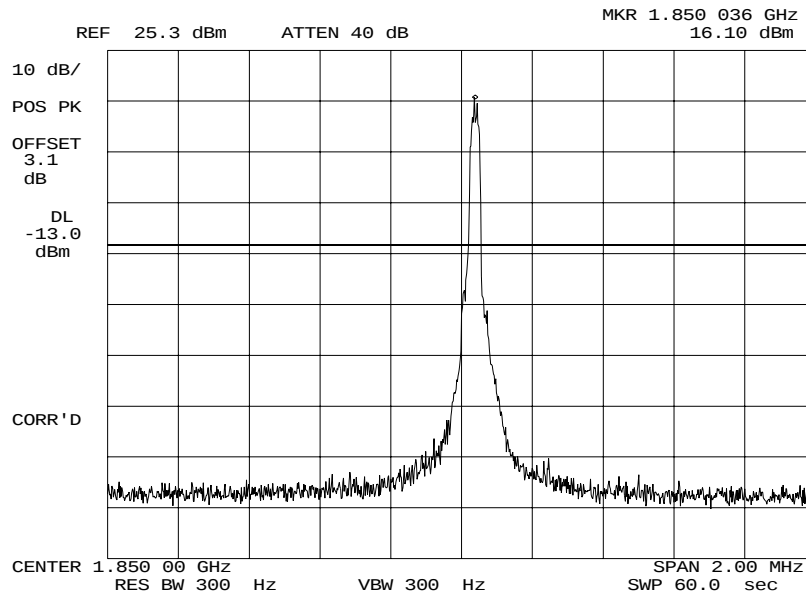
SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO.

44 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930237: 1999-Mar-23 Tue 14:40:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 TDMA
 LOWER BANDEDGE

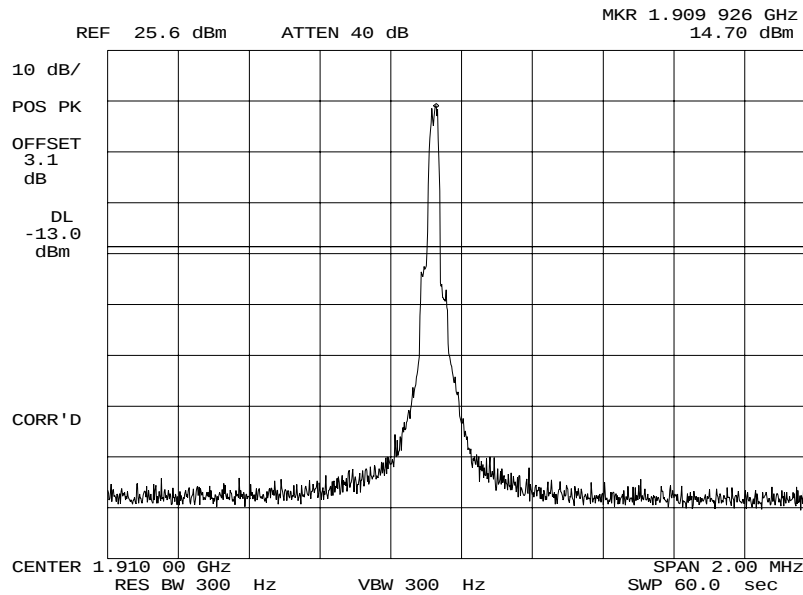
SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO.

45 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930238: 1999-Mar-23 Tue 14:50:00
 STATE: 2:High Power



POWER:
 MODULATION:

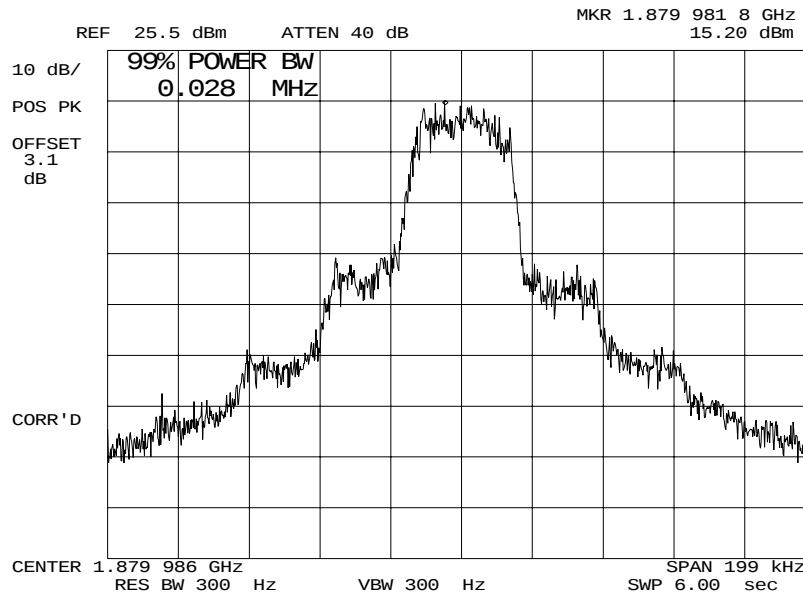
HIGH
 TDMA
 UPPER BANDEDGE

SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO. 46 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930240: 1999-Mar-23 Tue 14:57:00
 STATE: 2:High Power



POWER: HIGH
 MODULATION: TDMA
 99 % POWER BANDWIDTH

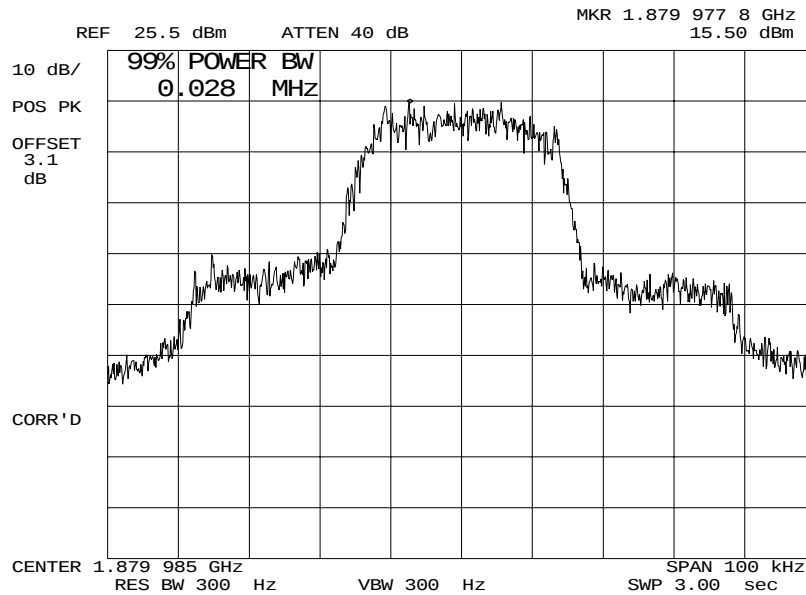
SUPERVISED BY:

Morton Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO.

47 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930239: 1999-Mar-23 Tue 14:55:00
 STATE: 2:High Power



POWER:
MODULATION:

HIGH
TDMA
99 % POWER BANDWIDTH

SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO. 48 of 72.

NAME OF TEST: Emission Requirements -
Worst Case Modulation & Wideband Data

SPECIFICATION: 47 CFR 22.917

GUIDE: TIA/EIA/IS-137-A-1996

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was connected to a coaxial attenuator and then to a spectrum analyzer. The unmodulated carrier was set for 0 dB reference level.
2. A notch filter was introduced to reduce or eliminate any spectrum analyzer internally generated spurious for measurements of the harmonics and the carrier level.
3. Spectrum analyzer bandwidth was set to section 22.917(h) as applicable.
4. Measurements were made on channels 380, 799 and 991. The equipment was first modulated for the Worst Case Modulation, then for Wideband Data (F8W, F1D).
5. All other spurious emissions over the range of 0 the beyond the 10th harmonic (10 GHz) were 20 dB or more below the limit
6. The data presented here is for the Worst Case.
7. MEASUREMENT RESULTS: ATTACHED

PAGE NO. 49 of 72.

MEASUREMENT SUMMARY: Emission Requirements -
Worst Case Modulation

WORST CASE MODULATION = VOICE +_SAT

EMISSION, MHz/HARM.	LIMIT, dBc	SPURIOUS EMISSIONS, dBc	
		Lo	Hi
F ₀ + (F ₀ + 20 kHz) to F ₀ + 45 kHz	≤ -26	≤ -44.0	≤ -48.0
F ₀ + (F ₀ + 45 kHz) to 2 nd Harmonic	≤ -60 or 43 + 10 log P	≤ -67.1	≤ -69.5
2 nd to 10 th	(≤ -13 dBm)	≤ -67.1	≤ -67.1

MEASUREMENT RESULTS = ATTACHED OFFSET PLOTS

EMISSION IN THE RECEIVER CRITICAL BAND

EMISSION, MHz/HARM.	LIMIT, dBm	SPURIOUS EMISSIONS, dBm	
		Lo	Hi
869 to 894	≤ -80	≤ -86.1	≤ -86.7

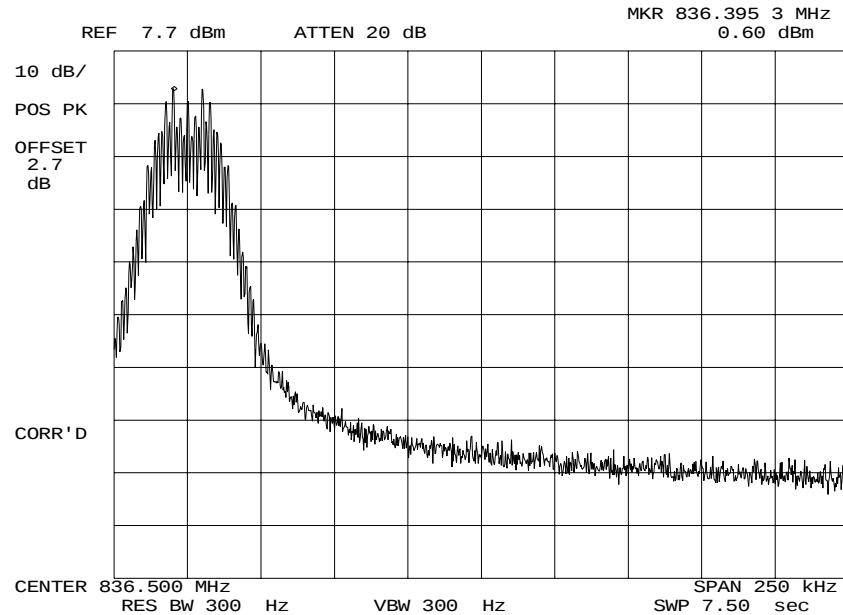
MEASUREMENT RESULTS = ATTACHED PLOTS

SUPERVISED BY:


Morton Flom, P. Eng.

PAGE NO. 50 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930222: 1999-Mar-23 Tue 11:35:00
 STATE: 1:Low Power



POWER:
 MODULATION:

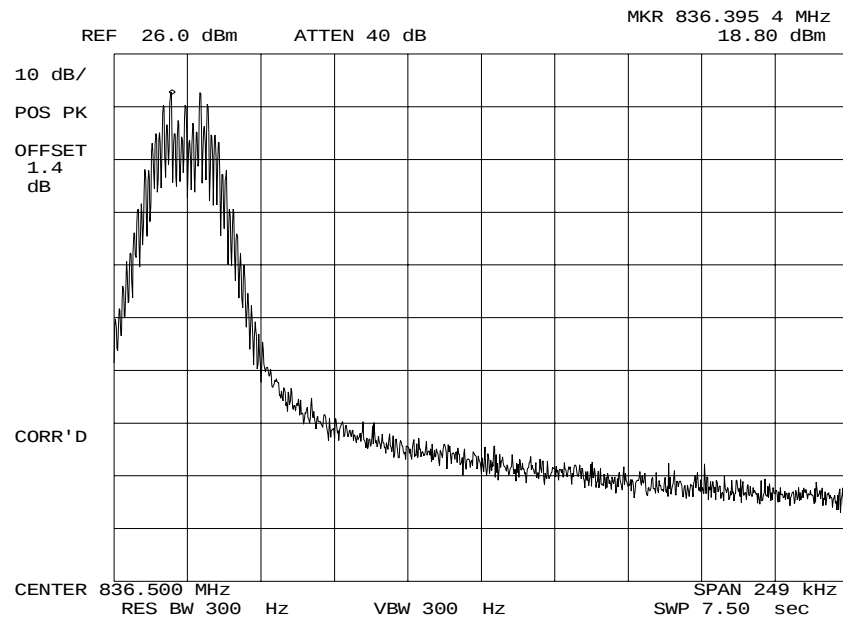
LOW
 SAT+VOICE
 OFFSET OCCUPIED BANDWIDTH

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 51 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
g9930221: 1999-Mar-23 Tue 11:33:00
STATE: 2:High Power



POWER:
MODULATION:

HIGH
SAT+VOICE
OFFSET OCCUPIED BANDWIDTH

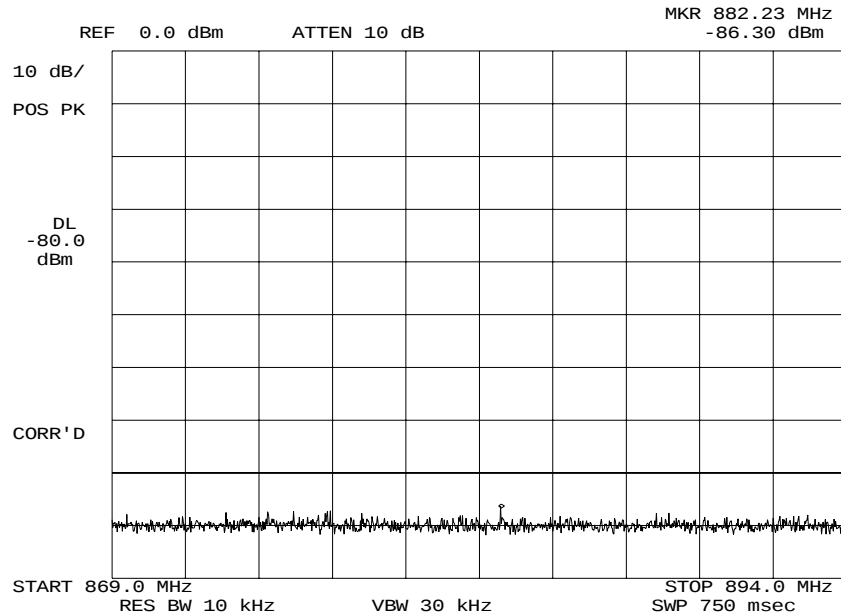
SUPERVISED BY:

M. Flom P. Eng.
Morton Flom, P. Eng.

PAGE NO.

52 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930229: 1999-Mar-23 Tue 11:55:00
 STATE: 2:Low Power



POWER:
 MODULATION:

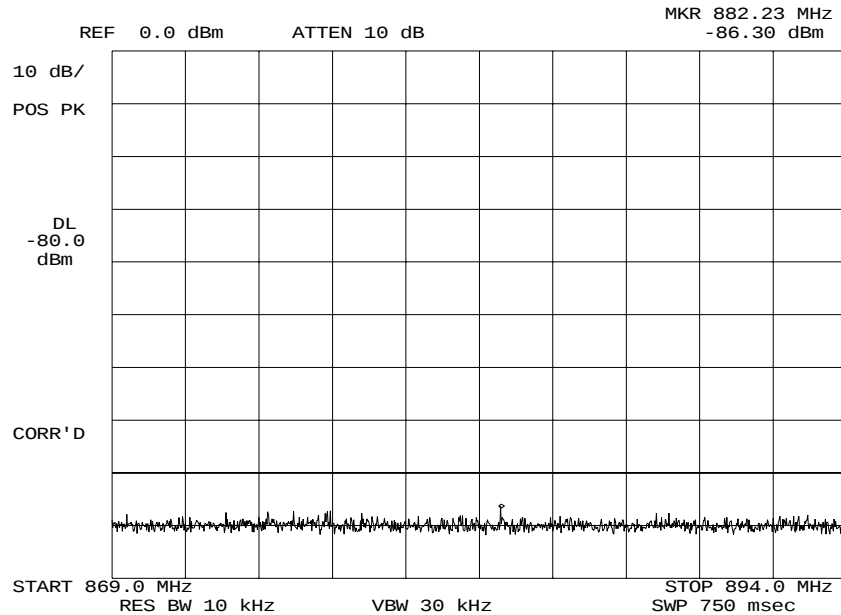
LOW
 SAT+VOICE
 TX SPURS IN RX CRITICAL
 BAND

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 53 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930229: 1999-Mar-23 Tue 11:55:00
 STATE: 2:High Power



POWER:
 MODULATION:

LOW
 SAT+VOICE
 TX SPURS IN RX CRITICAL
 BAND

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 54 of 72.

MEASUREMENT SUMMARY: Emission Requirements -
Wideband Data (F9D, 10 kb/s)

EMISSION, MHz/HARM.	LIMIT, dBc	SPURIOUS EMISSIONS, dBc	
		Lo	Hi
F ₀ + (F ₀ + 20 kHz) to F ₀ + 45 kHz	≤ -26	≤ -39.0	≤ -39.0
F ₀ + (F ₀ + 45 kHz) to F ₀ + 90 kHz	≤ -45	≤ -69.0	≤ -69.0
F ₀ + (F ₀ + 90 kHz) to 2 nd Harmonic	≤ -60 (≤ -13 dBm)	≤ -67.1	≤ -69.5
2 nd to 10 th	(≤ -13 dBm)	≤ -55.2	≤ -67.1

MEASUREMENT RESULTS = ATTACHED OFFSET PLOTS

EMISSION IN THE RECEIVER CRITICAL BAND

EMISSION, MHz/HARM.	LIMIT, dBm	SPURIOUS EMISSIONS, dBm	
		Lo	Hi
869 to 894	≤ -80	≤ -86.1	≤ -86.7

MEASUREMENT RESULTS = ATTACHED PLOTS

SUPERVISED BY:

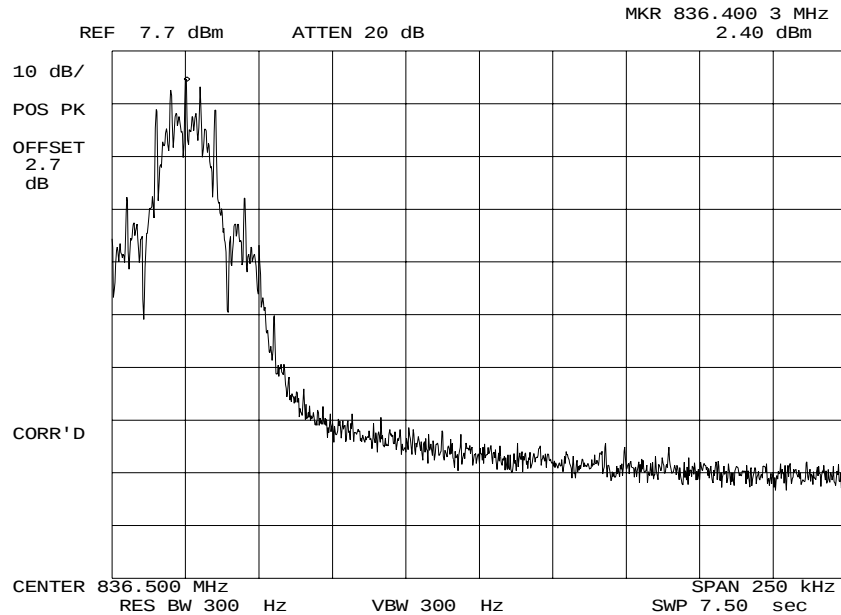


Morton Flom, P. Eng.

PAGE NO.

55 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930214: 1999-Mar-23 Tue 11:14:00
 STATE: 1:Low Power



POWER:
 MODULATION:

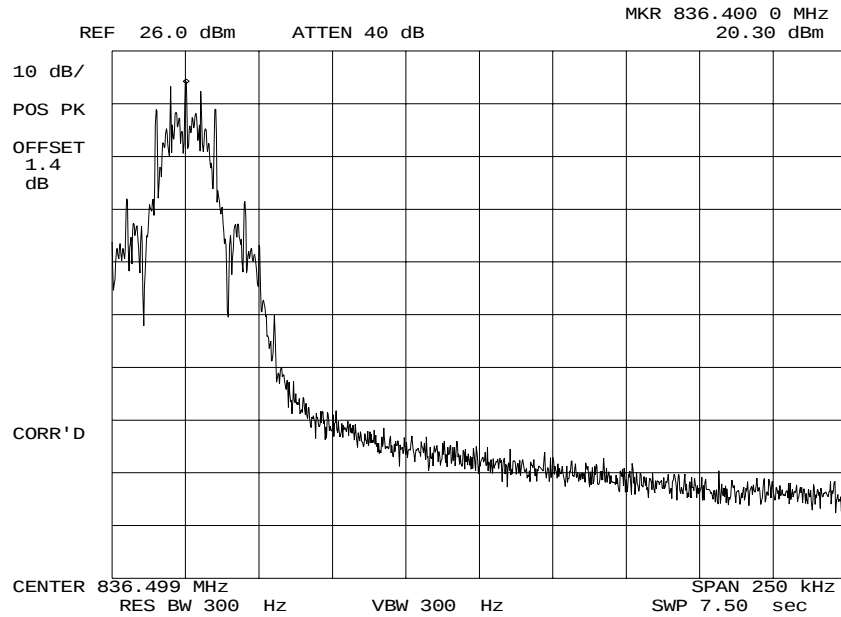
LOW
 WBD
 OFFSET OCCUPIED BANDWIDTH

SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 56 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930213: 1999-Mar-23 Tue 11:13:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 WBD
 OFFSET OCCUPIED BANDWIDTH

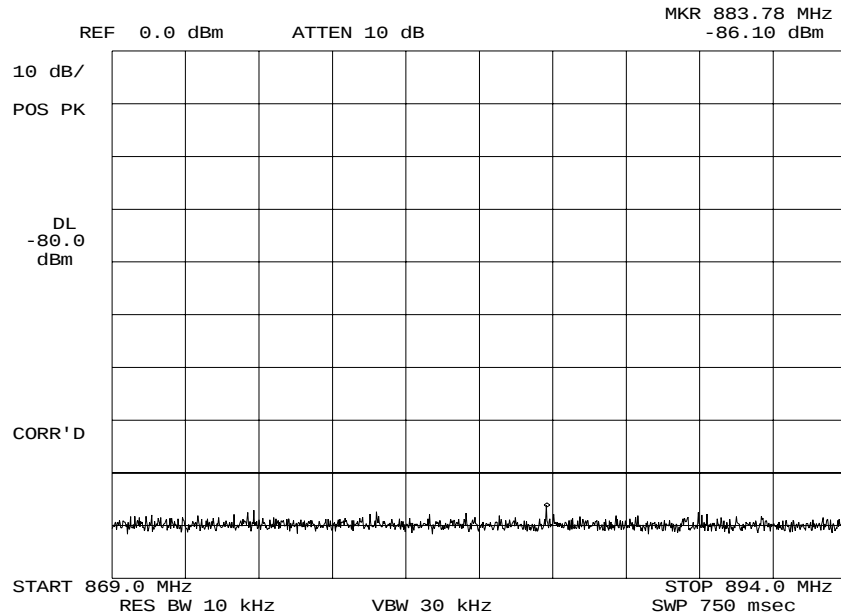
SUPERVISED BY:

M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO.

57 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930215: 1999-Mar-23 Tue 11:17:00
 STATE: 1:Low Power



POWER:
 MODULATION:

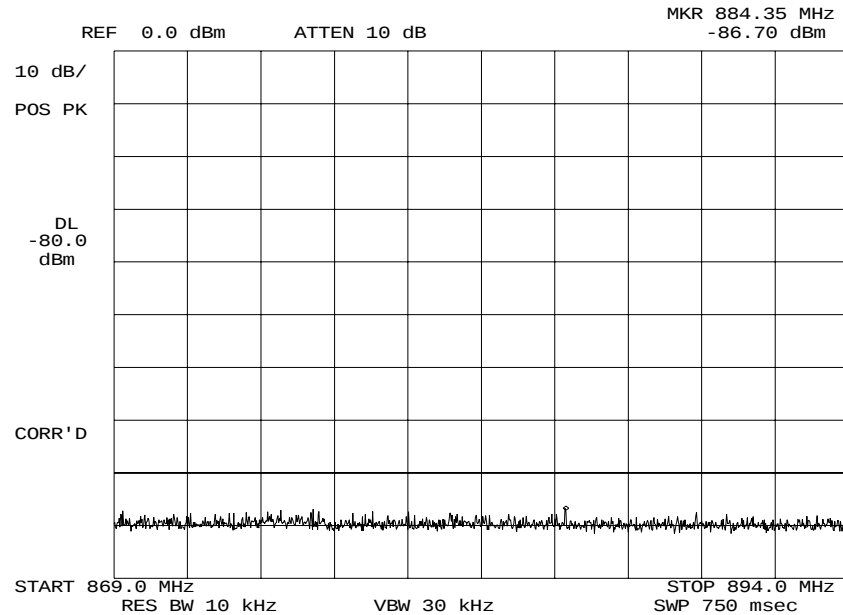
LOW
 WBD
 TX SPURS IN RX CRITICAL
 BAND

SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO. 58 of 72.

NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g9930216: 1999-Mar-23 Tue 11:18:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 WBD
 TX SPURS IN RX CRITICAL
 BAND

SUPERVISED BY:

Morton Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO. 59 of 72.
NAME OF TEST: Spurious Emissions at Antenna Terminals
SPECIFICATION: 47 CFR 2.1051, 22.917
GUIDE: TIA/EIA/IS-137-A-1996
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was connected to a coaxial attenuator and then to a Spectrum Analyzer.
2. A notch filter was introduced to reduce or eliminate spurious emission which could be generated internally in the spectrum analyzer.
3. Measurements were made over the range from 45 kHz to 10 GHz for the worst case modulation so both the highest and lowest R.F. power settings.
4. All other emissions were 20 dB or more below the limit.
5. Spectrum analyzer bandwidth was set to section 22.917(h) as applicable.
6. MEASUREMENT RESULTS: ATTACHED

PAGE NO. 60 of 72.

NAME OF TEST: Spurious Emissions at Antenna Terminals

NOT APPLICABLE

PAGE NO. 61 of 72.
NAME OF TEST: Field Strength of Spurious Radiation
SPECIFICATION: 47 CFR 2.1053(a)
GUIDE: TIA/EIA/IS-137-A-1996
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. A description of the measurement facilities was filed with the FCC and was found to be in compliance with the requirements of Section 15.38, by letter from the FCC dated March 3, 1997, FILE 31040/SIT. All pertinent changes will be reported to the Commission by up-date prior to March 2000.
2. At first, in order to locate all spurious frequencies and approximate amplitudes, and to determine proper equipment functioning, the test sample was set up at a distance of three meters from the test instrument. Valid spurious signals were determined by switching the power on and off.
3. In the field, the test sample was placed on a wooden turntable above ground at three (or thirty) meters away from the search antenna. Excess power leads were coiled near the power supply.

The cables were oriented in order to obtain the maximum response. At each emission frequency, the turntable was rotated and the search antennas were raised and lowered vertically.
4. The emission was observed with both a vertically polarized and a horizontally polarized search antenna and the worst case was used.
6. The field strength of each emission within 20 dB of the limit was recorded and corrected with the appropriate cable and transducer factors.
7. The worst case for all channels is shown.
8. Measurement results: ATTACHED FOR WORST CASE

PAGE NO. 63 of 72.

MEASUREMENT RESULTS: FIELD STRENGTH OF SPURIOUS RADIATION

Measurement Distance, m = 3

Spectrum Searched, GHz = 0 to 10

TUNED, MHz	CHANNEL NUMBER	EMISSION MHz/HARM.	LEVEL, dBc
AMPS-FM:			
824.040	991	2 nd - 10 th	<-70
836.400	380	2 nd - 10 th	<-70
848.970	799	2 nd - 10 th	<-70
AMPS-TDMA:			
824.040	991	2 nd - 10 th	<-70
836.400	380	2 nd - 10 th	<-70
848.970	799	2 nd - 10 th	<-70
PCS-TDMA:			
1850.04		2 nd - 10 th	<-55
1878.98		2 nd - 10 th	<-55
1909.92		2 nd - 10 th	<-55

NOTE:

For channels 380, 799 and 991, the field strength of spurious radiation over the above noted range measured 20 dB or more below the limit.

SUPERVISED BY:



Morton Flom, P. Eng.

PAGE NO.

64 of 72.

NAME OF TEST: Field Strength of Spurious Radiation
 g9930253: 1999-Mar-24 Wed 11:06:00
 STATE: 1:Low Power AMPS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	uV/m @ 3m	ERP, dBm	MARGIN, dB
836.400000	1672.805000	29.67	1.86	37.71	-65.85	-52.9
836.400000	2509.205000	34.17	6.46	107.52	-56.75	-43.8
836.400000	3345.605000	31.83	8.55	104.47	-56.95	-44
836.400000	4182.005000	32.33	10.66	141.09	-54.35	-41.4
836.400000	5018.405000	31.67	12.95	170.22	-52.75	-39.8
836.400000	5854.805000	30	15.07	179.27	-52.35	-39.3
836.400000	6691.205000	30.83	18.23	283.79	-48.35	-35.3
836.400000	7527.605000	31.33	19.6	351.97	-46.45	-33.5
836.400000	8364.005000	33.33	20.04	466.12	-44.05	-31

(P: Peak reading, A: Average reading)

NAME OF TEST: Field Strength of Spurious Radiation
 g9930252: 1999-Mar-24 Wed 09:12:00
 STATE: 2:High Power AMPS

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	uV/m @ 3m	ERP, dBm	MARGIN, dB
836.400000	1672.785000	33.67	31.86	1890.17	-31.85	-18.9
836.400000	2509.193333	61.5	6.46	2500.35	-29.45	-16.4
836.400000	3345.613333	39.33	8.55	247.74	-49.45	-36.5
836.400000	4182.006667	39.83	10.66	334.58	-46.85	-33.9
836.400000	5018.401667	49.5	12.95	1325.87	-34.95	-22
836.400000	5854.805000	41.5	15.07	673.75	-40.85	-27.8
836.400000	6691.205000	33.67	18.23	393.55	-45.45	-32.5
836.400000	7527.605000	31.83	19.6	372.82	-45.95	-33
836.400000	8364.005000	31	20.04	356.45	-46.35	-33.4

(P: Peak reading, A: Average reading)

PAGE NO.

65 of 72.

NAME OF TEST: Field Strength of Spurious Radiation
 g9930251: 1999-Mar-24 Wed 09:09:00
 STATE: 1:Low Power AMPS-TDMA

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	uV/m @ 3m	ERP, dBm	MARGIN, dB
836.400000	1672.800000	34.5	1.86	65.77	-61.05	-48
836.400000	2509.200000	32.5	6.46	88.72	-58.45	-45.4
836.400000	3345.600000	32.17	8.55	108.64	-56.65	-43.7
836.400000	4182.000000	32.33	10.66	141.09	-54.35	-41.4
836.400000	5018.400000	32.67	12.95	190.99	-51.75	-38.8
836.400000	5854.800000	32.17	15.07	230.14	-50.15	-37.2
836.400000	6691.200000	30.83	18.23	283.79	-48.35	-35.3
836.400000	7527.600000	32.17	19.6	387.7	-45.65	-32.6
836.400000	8364.000000	33	20.04	448.75	-44.35	-31.4

(P: Peak reading, A: Average reading)

NAME OF TEST: Field Strength of Spurious Radiation
 g9930246: 1999-Mar-23 Tue 14:56:00
 STATE: 2:High Power AMPS-TDMA

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	uV/m @ 3m	ERP, dBm	MARGIN, dB
836.400000	1672.786667	39.83	31.86	3841.49	-25.65	-12.7
836.400000	2509.193333	65.67	6.46	4041.1	-25.25	-12.3
836.400000	3345.585000	42.33	8.55	349.95	-46.45	-33.5
836.400000	4181.960000	41.33	10.66	397.65	-45.35	-32.4
836.400000	5018.393333	46.5	12.95	938.64	-37.95	-25
836.400000	5854.846667	48.67	15.07	1538.15	-33.65	-20.7
836.400000	6691.246667	31.67	18.23	312.61	-47.45	-34.5
836.400000	7527.646667	31.5	19.6	358.92	-46.25	-33.3
836.400000	8364.046667	33.83	20.04	493.74	-43.55	-30.5

(P: Peak reading, A: Average reading)

PAGE NO.

66 of 72.

NAME OF TEST: Field Strength of Spurious Radiation
 g9930234: 1999-Mar-23 Tue 14:50:00
 STATE: 1:Low Power PCS-TDMA

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	uV/m @ 3m	EIRP, dBm	MARGIN, dB
1879.980000	3759.988333	31.17	9.56	108.77	-56.65	-41.5
1879.980000	5639.968333	30.17	14.55	172.19	-52.65	-37.5
1879.980000	7519.948333	26.67	19.59	205.59	-51.15	-35.9
1879.980000	9399.928333	28.33	22.96	366.86	-46.05	-30.9
1879.980000	11279.908333	30.67	23.84	531.5	-42.85	-27.7
1879.980000	13159.888333	29	26.89	623.02	-41.45	-26.3
1879.980000	15039.868333	28.33	23.51	390.84	-45.55	-30.4
1879.980000	16919.848333	29.33	30.35	963.83	-37.65	-22.5

(P: Peak reading, A: Average reading)

NAME OF TEST: Field Strength of Spurious Radiation
 g9930193: 1999-Mar-23 Tue 09:06:00
 STATE: 2:High Power PCS-TDMA

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	METER, dBuV	CF, dB	uV/m @ 3m	EIRP, dBm	MARGIN, dB
1879.980000	3759.978333	60	9.56	3006.08	-27.85	-12.6
1879.980000	5640.008333	61.5	14.55	6346	-21.35	-6.2
1879.980000	7519.958333	45	19.59	1696.29	-32.75	-17.6
1879.980000	9400.018334	47	22.96	3147.75	-27.45	-12.2
1879.980000	11280.035000	34	23.84	779.83	-39.55	-24.4
1879.980000	13160.015000	24.17	26.89	357.27	-46.35	-31.1
1879.980000	15039.995000	27.67	23.51	362.24	-46.15	-31
1879.980000	16919.975000	27.17	30.35	751.62	-39.85	-24.7

(P: Peak reading, A: Average reading)

PAGE NO. 67 of 72.
NAME OF TEST: Frequency Stability (Temperature Variation)
SPECIFICATION: 47 CFR 2.1055(a)(1)
GUIDE: TIA/EIA/IS-137-A-1996
TEST CONDITIONS: As Indicated
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

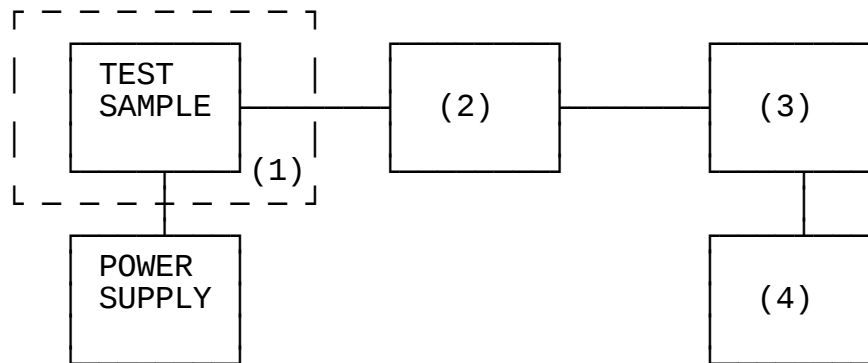
1. The EUT and test equipment were set up as shown on the following page.
2. With all power removed, the temperature was decreased to -30°C and permitted to stabilize for three hours. Power was applied and the maximum change in frequency was noted within one minute.
3. With power OFF, the temperature was raised in 10°C steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted within one minute.
4. The temperature tests were performed for the worst case.
5. MEASUREMENT RESULTS: ATTACHED

PAGE NO.

68 of 72.

TRANSMITTER TEST SET-UP

TEST A. OPERATIONAL STABILITY
 TEST B. CARRIER FREQUENCY STABILITY
 TEST C. OPERATIONAL PERFORMANCE STABILITY
 TEST D. HUMIDITY
 TEST E. VIBRATION
 TEST F. ENVIRONMENTAL TEMPERATURE
 TEST G. FREQUENCY STABILITY: TEMPERATURE VARIATION
 TEST H. FREQUENCY STABILITY: VOLTAGE VARIATION



Asset	Description	s/n
(1) TEMPERATURE, HUMIDITY, VIBRATION		
<u>x</u>	i00027 Tenny Temp. Chamber	9083-765-234
<u> </u>	i00 Weber Humidity Chamber	
<u> </u>	i00 L.A.B. RVH 18-100	
(2) COAXIAL ATTENUATOR		
<u>x</u>	i00122 NARDA 766-10	7802
<u> </u>	i00123 NARDA 766-10	7802A
<u> </u>	i00113 SIERRA 661A-3D	1059
<u> </u>	i00069 BIRD 8329 (30 dB)	10066
(3) R.F. POWER		
<u> </u>	i00014 HP 435A POWER METER	1733A05839
<u>x</u>	i00039 HP 436A POWER METER	2709A26776
<u>x</u>	i00020 HP 8901A POWER MODE	2105A01087
(4) FREQUENCY COUNTER		
<u> </u>	i00042 HP 5383A	1628A00959
<u> </u>	i00019 HP 5334B	2704A00347
<u>x</u>	i00020 HP 8901A	2105A01087

PAGE NO.

69 of 72.

FREQUENCY STABILITY (WORST CASE OF ANALOGUE)

TEMP. °C	NOMINAL VOLT, ppm	LOW VOLTAGE, ppm	HIGH VOLTAGE, ppm
-30	-0.1	-0.4	0.0
-20	0.1	0.2	0.1
-10	-0.2	-0.2	-0.2
0	-0.3	-0.4	-0.3
10	-0.4	-0.4	-0.3
20	-0.3	-0.3	-0.3
25	-0.1	-0.1	-0.1
30	0.0	0.0	0.0
40	0.3	0.3	0.4
50	0.6	0.6	0.6
60	0.6	0.7	0.6

FREQUENCY STABILITY (WORST CASE OF DIGITAL)

TEMP. °C	NOMINAL VOLT, ppm	LOW VOLTAGE, ppm	HIGH VOLTAGE, ppm
-30	-0.1	-0.4	0.0
-20	0.1	0.2	0.1
-10	-0.2	-0.2	-0.2
0	-0.3	-0.4	-0.3
10	-0.4	-0.4	-0.3
20	-0.3	-0.3	-0.3
25	-0.1	-0.1	-0.1
30	0.0	0.0	0.0
40	0.3	0.3	0.4
50	0.6	0.6	0.6
60	0.6	0.7	0.6

PAGE NO.

70 of 72.

FREQUENCY STABILITY (WORST CASE OF PCS)

TEMP. °C	NOMINAL VOLT, ppm	LOW VOLTAGE, ppm	HIGH VOLTAGE, ppm
-30	-0.1	-0.4	0.0
-20	0.1	0.2	0.1
-10	-0.2	-0.2	-0.2
0	-0.3	-0.4	-0.3
10	-0.4	-0.4	-0.3
20	-0.3	-0.3	-0.3
25	-0.1	-0.1	-0.1
30	0.0	0.0	0.0
40	0.3	0.3	0.4
50	0.6	0.6	0.6
60	0.6	0.7	0.6

SUPERVISED BY:



Morton Flom, P. Eng.

PAGE NO. 71 of 72.

NAME OF TEST: Frequency Stability (Voltage Variation)

SPECIFICATION: 47 CFR 2.1055 (b)(1)

GUIDE: TIA/EIA/IS-137-A-1996

TEST EQUIPMENT: As per previous page
MEASUREMENT PROCEDURE

1. The EUT was placed in a temperature chamber at $25 \pm 5^\circ\text{C}$ and connected as for "Frequency Stability - Temperature Variation" test.
2. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
3. The variation in frequency was measured for the worst case.

RESULTS: Frequency Stability (Voltage Variation)

STATE: 0:General AMPS MODE

LIMIT, ppm = 2.5

LIMIT, Hz = 2091

BATTERY END POINT (Voltage) = 3.1

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	3.2	836.399910	-90	-0.1
100	3.8	836.399908	-92	-0.1
115	4.4	836.399916	-84	-0.1
B.E.P.	3.1	836.399910	-85	-0.1

RESULTS: Frequency Stability (Voltage Variation)

STATE: 0:General AMPS-TDMA MODE

LIMIT, ppm = 2.5

LIMIT, Hz = 2091

BATTERY END POINT (Voltage) = 3.1

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	3.2	836.399990	-10	0.0
100	3.8	836.399987	-19	0.0
115	4.4	836.399991	-9	0.0
B.E.P.	3.1	836.400021	21	0.0

RESULTS: Frequency Stability (Voltage Variation)

STATE: 0:General PCS-TDMA MODE

LIMIT, ppm = 2.5

LIMIT, Hz = 4700

BATTERY END POINT (Voltage) = 3.1

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	3.2	1879.980003	3	0.0
100	3.8	1879.980011	11	0.0
115	4.4	1879.980005	5	0.0
B.E.P.	3.1	1879.979991	-9	0.0

SUPERVISED BY:

Morton Flom, P. Eng.

PAGE NO. 72 of 72.

NAME OF TEST: Necessary Bandwidth and Emission Bandwidth

SPECIFICATION: 47 CFR 2.202(g)

MODULATION = 40K0F8W

NECESSARY BANDWIDTH:

NECESSARY BANDWIDTH (B_N), kHz = 40
(measured at the 99.75% power bandwidth)

MODULATION = 40K0F1D

NECESSARY BANDWIDTH:

NECESSARY BANDWIDTH (B_N), kHz = 40
(measured at the 99.75% power bandwidth)

MODULATION = 30K0DXW

NECESSARY BANDWIDTH:

NECESSARY BANDWIDTH (B_N), kHz = 30
(measured at the 99.75% power bandwidth)

SUPERVISED BY:



Morton Flom, P. Eng.

TESTIMONIAL
AND
STATEMENT OF CERTIFICATION

THIS IS TO CERTIFY THAT:

1. THAT the application was prepared either by, or under the direct supervision of, the undersigned.
2. THAT the technical data supplied with the application was taken under my direction and supervision.
3. THAT the data was obtained on representative units, randomly selected.
4. THAT, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

CERTIFYING ENGINEER:


Morton Flom, P. Eng.